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High-Reliability, Ultra-Low-Power Microcontroller Powered by Arm Cortex-M4 Processor with FPU for Industrial and IoT

General Description

In the Darwin family, the MAX32670/MAX32671 are ultralow-power, cost-effective, high-reliability 32-bit microcontrollers enabling designs with complex sensor processing without compromising battery life. They combine a flexible and versatile power management unit with the powerful Arm® Cortex®-M4 processor with a floating point unit (FPU). The MAX32670/MAX32671 also offer legacy designs an easy and cost optimal upgrade path from 8- or 16-bit microcontrollers.

The devices integrate up to 384KB of flash and 160KB of SRAM to accommodate application and sensor code. Error correction coding (ECC), capable of single error correction and double error detection (SEC-DED), is implemented over the entire flash, RAM, and cache to ensure ultra-reliable code execution for demanding applications. Additional features such as the two windowed watchdog timers with fully flexible and independent clocking have been added to further enhance reliable operation. Brownout detection ensures proper operation during power-down/power-up events and unexpected supply transients.

Multiple high-speed peripherals such as 3.4MHz I²C, 50MHz SPI, and 4MBd UARTs are included to maximize communication bandwidth. In addition, a low-power UART is available for operation in the lowest power sleep modes to facilitate wakeup on activity without any loss of data. A total of six timers with I/O capability are provided, including two low-power timers to enable pulse counting, capture/compare, and PWM generation even in the lowest power sleep modes. All of this capability is packaged in a tiny form factor: 5mm x 5mm, 40-pin TQFN-EP.

Applications

- Smart Sensor Controller
- Industrial Sensors
- Optical Communication Modules
- Secure Radio Modem Controller
- Battery-Powered Medical Devices
- System Housekeeping Controller
- Algorithm Coprocessor

Ordering Information appears at end of data sheet.

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CoreMark is a registered trademark of EEMBC.

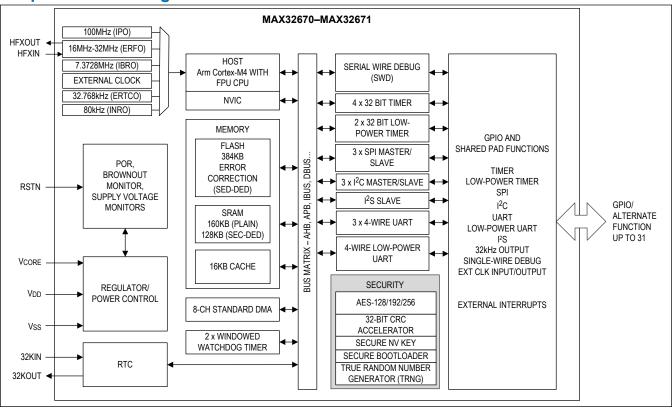
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Benefits and Features

- High-Efficiency Microcontroller for Low-Power, High-Reliability Devices
 - Arm Cortex-M4 Core with FPU up to 100MHz
 - 384KB Flash Memory with Error Correction
 - 160KB SRAM (128KB with ECC Enabled), Optionally Preserved in Lowest Power Modes
 - · 16KB Unified Cache with ECC
 - · UART Bootloader
 - · Dual- or Single-Supply Operation
 - Ultra-Low 0.9V to 1.1V V_{CORE} Supply Voltage
 - Internal LDO Operation from 1.7V to 3.6V Single Supply
 - Wide Operating Temperature: -40°C to +105°C
- Flexible Clocking Schemes
 - Internal High-Speed 100MHz Oscillator
 - Internal Low-Power 7.3728MHz and Ultra-Low-Power 80kHz Oscillators
 - 16MHz to 32MHz Oscillator (External Crystal Required)
 - 32.768kHz Oscillator (External Crystal Required)
 - · External Clock Input for the Core
 - External Clock Input for the LPUART and LPTMR
- Power Management Maximizes Uptime for Battery Applications
 - 44µA/MHz Active at 0.9V up to 12MHz
 - 50µA/MHz Active at 1.1V up to 100MHz
 - 2.6μA Full Memory Retention Power in BACKUP Mode at V_{DD} = 1.8V
 - 350nA Ultra-Low-Power RTC at V_{DD} = 1.8V
 - · Wake from LPUART or LPTMR
- Optimal Peripheral Mix Provides Platform Scalability
 - Up to 31 General-Purpose I/O Pins
 - Up to Three SPI Master/Slave (up to 50MHz)
 - · Up to Three 4-Wire UART
 - One Low-Power UART (LPUART)
 - Up to Three I²C Master/Slave 3.4Mbps High Speed
 - 8-Channel Standard DMA Controller
 - Up to Four 32-Bit Timers (TMR)
 - Up to Two Low-Power 32-Bit Timers (LPTMR)
 - Two Windowed Watchdog Timers
 - One I²S Slave for Digital Audio Interface
- · Security and Integrity
 - · Available Secure Boot
 - AES 128/192/256 Hardware Acceleration Engine
 - · 32-Bit CRC Acceleration Engine

19-100782; Rev 3; 5/22

Simplified Block Diagram



High-Reliability, Ultra-Low-Power Microcontroller Powered by Arm Cortex-M4 Processor with FPU for Industrial and IoT

TABLE OF CONTENTS

General Description	
Applications	1
Benefits and Features	
Simplified Block Diagram	
Absolute Maximum Ratings	7
Package Information	7
40 TQFN-EP	7
Electrical Characteristics	
Electrical Characteristics—SPI	
Electrical Characteristics—I ² C	
Electrical Characteristics—I ² S Slave	
Pin Configuration	
40 TQFN	
Pin Description	
Detailed Description	
Arm Cortex-M4 Processor with FPU Engine	
Memory	
Internal Flash Memory	
Internal SRAM	
Clocking Scheme	
General-Purpose I/O and Special Function Pins	
Standard DMA Controller	
Power Management	
Power Management Unit	39
ACTIVE Mode	39
SLEEP Mode	39
DEEPSLEEP Mode	
BACKUP Mode	40
STORAGE Mode	40
Real-Time Clock	
Windowed Watchdog Timer (WWDT)	40
32-Bit Timer/Counter/PWM (TMR, LPTMR)	41
Serial Peripherals	42
I ² C Interface (I2C)	42
Serial Peripheral Interface (SPI)	42
I ² S Interface (I2S)	43
UART (UART, LPUART)	43
Security	44
AES	44

High-Reliability, Ultra-Low-Power Microcontroller Powered by Arm Cortex-M4 Processor with FPU for Industrial and IoT

TABLE OF CONTENTS (CONTINUED)

True Random Number Generator (TRNG)	44
CRC Module	44
Bootloader	44
Secure Boot	44
Debug and Development Interface (SWD)	45
Applications Information	46
Bypass Capacitors	46
Bootloader Activation	46
Typical Fixed Current Consumption Temperature Variance	
Single-Supply ACTIVE Mode	46
Single-Supply SLEEP Mode	47
Single-Supply DEEPSLEEP Mode	47
Single-Supply BACKUP Mode	47
Single-Supply STORAGE Mode	48
Dual-Supply ACTIVE Mode	48
Dual-Supply ACTIVE Mode	48
Dual-Supply SLEEP Mode	49
Dual-Supply SLEEP Mode	49
Dual-Supply DEEPSLEEP Mode	50
Dual-Supply DEEPSLEEP Mode	50
Dual-Supply BACKUP Mode	50
Dual-Supply BACKUP Mode	52
Dual-Supply STORAGE Mode	53
Dual-Supply STORAGE Mode	53
Ordering Information	54
Revision History	55

High-Reliability, Ultra-Low-Power Microcontroller Powered by Arm Cortex-M4 Processor with FPU for Industrial and IoT

LIST OF FIGURES

Figure 1. Power-Supply Operational Modes	30
Figure 2. SPI Master Mode Timing Diagram	31
Figure 3. SPI Slave Mode Timing Diagram	31
Figure 4. I ² C Timing Diagram	32
Figure 5. I ² S Timing Diagram	32
Figure 6. Clocking Scheme	38

High-Reliability, Ultra-Low-Power Microcontroller Powered by Arm Cortex-M4 Processor with FPU for Industrial and IoT

LIST OF TABLES

able 1. BACKUP Mode RAM Retention	40
able 2. Timer Configuration Options	41
able 3. SPI Configuration Options	42
able 4. UART Configuration Options	43
able 5. Bootloader Activation Summary	46
able 6. Single-Supply Operation Fixed V _{DD} Current Consumption ACTIVE Mode	46
able 7. Single-Supply Operation Fixed V _{DD} Current Consumption SLEEP Mode	47
able 8. Single-Supply Operation Fixed V _{DD} Current Consumption DEEPSLEEP Mode	47
able 9. Single-Supply Operation Fixed V _{DD} Current Consumption BACKUP Mode	47
able 10. Single-Supply Operation Fixed V _{DD} Current Consumption STORAGE Mode	48
able 11. Dual-Supply Operation Fixed V _{CORE} Current Consumption ACTIVE Mode	48
able 12. Dual-Supply Operation Fixed V _{DD} Current Consumption ACTIVE Mode	48
able 13. Dual-Supply Operation Fixed V _{CORE} Current Consumption SLEEP Mode	49
able 14. Dual-Supply Operation Fixed V _{DD} Current Consumption SLEEP Mode	49
able 15. Dual-Supply Operation Fixed V _{CORE} Current Consumption DEEPSLEEP Mode	50
able 16. Dual-Supply Operation Fixed V _{DD} Current Consumption DEEPSLEEP Mode	50
able 17. Dual-Supply Operation Fixed V _{CORE} Current Consumption BACKUP Mode	50
able 18. Dual-Supply Operation Fixed V _{DD} Current Consumption BACKUP Mode	52
able 19. Dual-Supply Operation Fixed V _{CORE} Current Consumption STORAGE Mode	53
able 20. Dual-Supply Operation Fixed V _{DD} Current Consumption STORAGE Mode	53

High-Reliability, Ultra-Low-Power Microcontroller Powered by Arm Cortex-M4 Processor with FPU for Industrial and IoT

Absolute Maximum Ratings

(All voltages with respect to V_{SS} , unless otherwise noted.)	Output Current (source) by Any GPIO Pin Continuous Package Power Dissipation 4 board) $T_A = +70^{\circ}C$ (derate $+70^{\circ}C$)	0 TQFN-EP (multilayer 35.7mW/°C above 2857.10mW 40°C to +105°C 65°C to +150°C
Output Current (sink) by Any GPIO Pin	Soldering Temperature (Tellow)	1200 C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Package Information

40 TQFN-EP

Package Code	T4055+1
Outline Number	<u>21-0140</u>
Land Pattern Number	<u>90-0016</u>
Thermal Resistance, Single-Layer Board:	
Junction to Ambient (θ _{JA})	45°C/W
Junction to Case (θ_{JC})	2°C/W
Thermal Resistance, Four-Layer Board:	
Junction to Ambient (θ _{JA})	28°C/W
Junction to Case (θ _{JC})	2°C/W

For the latest package outline information and land patterns (footprints), go to www.maximintegrated.com/packages. Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a four-layer board. For detailed information on package thermal considerations, refer to www.maximintegrated.com/thermal-tutorial.

Electrical Characteristics

(Limits are 100% tested at $T_A = +25^{\circ}$ C and $T_A = +105^{\circ}$ C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
POWER / BOTH SINGLE	-SUPPLY OPER	ATION AND DUAL	-SUPPLY OPERATION				
Supply Voltage	V_{DD}			1.71	1.8	3.63	V
			OVR = [00]	0.855	0.9	0.945	
Supply Voltage, Core V _{CORE}		Dual-supply operation	OVR = [01]	0.95	1.0	1.05	V
	ороганоп	Default OVR = [10]	1.045	1.1	1.155	1	
		No power supply connection for single supply operation			_		
Davies Feil Daset		Monitors V _{DD}		1.58		1.71	
Power-Fail Reset Voltage	V _{RST}	Monitors V _{CORE} during dual-supply operation		0.77	0.845	0.845	V
		Monitors V _{DD}			1.4		
Power-on-Reset Voltage	V _{POR}	Monitors V _{CORE} during dual-supply operation			0.58		V

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	COND	CONDITIONS		TYP	MAX	UNITS																
POWER / SINGLE-SUPP	LY OPERATION	(V _{DD} ONLY)		1			•																
V _{DD} Current ACTIVE Mode I _{DD_DACTS}		Dynamic, IPO enabled, total current into V _{DD}	OVR = [10], internal regulator set to 1.1V, fsys_clk(MAX) = 100MHz		57.5																		
		pin, V _{DD} = 3.3V, CPU in ACTIVE mode, executing CoreMark [®] , ECC disabled, inputs	OVR = [01], internal regulator set to 1.0V, fSYS_CLK(MAX) = 50MHz		55.7																		
	tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [00], internal regulator set to 0.9V, fSYS_CLK(MAX) = 12MHz		52.2																			
	Dynamic, IPO enabled, total current into V _{DD}	OVR = [10], internal regulator set to 1.1V, fsys_CLK(MAX) = 100MHz		56.9																			
	IDD_DACTS	pin, V _{DD} = 1.8V, CPU in ACTIVE	pin, V _{DD} = 1.8V, CPU in ACTIVE mode, executing CoreMark, ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink	pin, V _{DD} = 1.8V, CPU in ACTIVE mode, executing CoreMark, ECC	CPU in ACTIVE mode, executing CoreMark, ECC disabled, inputs	CPU in ACTIVE mode, executing CoreMark, ECC disabled, inputs	CPU in ACTIVE mode, executing CoreMark, ECC disabled, inputs	CPU in ACTIVE mode, executing CoreMark, ECC	CPU in ACTIVE mode, executing CoreMark, ECC	CPU in ACTIVE mode, executing CoreMark, ECC disabled, inputs	CPU in ACTIVE mode, executing CoreMark, ECC disabled, inputs	CPU in ACTIVE mode, executing CoreMark, ECC disabled, inputs	OVR = [01], internal regulator set to 1.0V, fsys_CLK(MAX) = 50MHz		55.3		μΑ/MHz						
				OVR = [00], internal regulator set to 0.9V, fSYS_CLK(MAX) = 12MHz		52																	
			OVR = [10], internal regulator set to 1.1V, fsys_clk(MAX) = 100MHz		43																		
			OVR = [01], internal regulator set to 1.0V, fSYS_CLK(MAX) = 50MHz		40.7																		
			OVR = [00], internal regulator set to 0.9V, fSYS_CLK(MAX) = 12MHz		37.5																		

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	COND	ITIONS	MIN TYP	MAX	UNITS		
		Dynamic, IPO enabled, total current into V _{DD} pin, V _{DD} = 1.8V, CPU in ACTIVE mode, executing While(1), ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [10], internal regulator set to 1.1V, fSYS_CLK(MAX) = 100MHz	42.4				
			OVR = [01], internal regulator set to 1.0V, f _{SYS} CLK(MAX) = 50MHz	40.5				
			OVR = [00], internal regulator set to 0.9V, f _{SYS} CLK(MAX) = 12MHz	38.2				
		Fixed, IPO enabled, total current into V _{DD}	OVR = [10], internal regulator set to 1.1V. See <u>Temperature</u> <u>Variance</u>	735				
	pir CF mc ex dis	pin, V _{DD} = 3.3V, CPU in ACTIVE mode 0MHz execution, ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [01], internal regulator set to 1.0V. See <u>Temperature</u> <u>Variance</u>	659				
			outputs source/sink	outputs source/sink 0mA	OVR = [00], internal regulator set to 0.9V. See <u>Temperature</u> <u>Variance</u>	563		
	IDD_FACTS		OVR = [10], internal regulator set to 1.1V. See <u>Temperature</u> <u>Variance</u>	754		– μΑ		
			pin, V _{DD} = 1.8V, CPU in ACTIVE mode 0MHz execution, ECC	OVR = [01], internal regulator set to 1.0V. See <u>Temperature</u> <u>Variance</u>	663			
			OVR = [00], internal regulator set to 0.9V. See <u>Temperature</u> <u>Variance</u>	538				

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	COND	ITIONS	MIN	TYP	MAX	UNITS
V _{DD} Current SLEEP Mode I _{DD_DSLPS}		Dynamic, IPO enabled, total current into V _{DD} pin, V _{DD} = 3.3V, CPU in SLEEP mode, ECC disabled, standard DMA with two channels active.	OVR = [10], internal regulator set to 1.1V, fSYS_CLK(MAX) = 100MHz		30		
			OVR = [01], internal regulator set to 1.0V, f _{SYS} CLK(MAX) = 50MHz		28.8		
	inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [00], internal regulator set to 0.9V, f _{SYS} CLK(MAX) = 12MHz		28.0			
	Dynamic, IPO enabled, total current into V _{DD}	OVR = [10], internal regulator set to 1.1V, fSYS_CLK(MAX) = 100MHz		36.4			
	I _{DD_DSLPS}	pin, V _{DD} = 1.8V, CPU in SLEEP mode, ECC disabled, standard DMA with two channels active, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [01], internal regulator set to 1.0V, fSYS_CLK(MAX) = 50MHz		28.5		μΑ/MHz
			OVR = [00], internal regulator set to 0.9V, fSYS_CLK(MAX) = 12MHz		28.1		
		Dynamic, IPO enabled, total current into V _{DD}	OVR = [10], internal regulator set to 1.1V, fSYS_CLK(MAX) = 100MHz		13.4		
	pin, V _{DD} = 3.3V, CPU in SLEEP mode, ECC disabled, DMA disabled, inputs	OVR = [01], internal regulator set to 1.0V, fsys_CLK(MAX) = 50MHz		11.8			
		tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [00], internal regulator set to 0.9V, fsys_CLK(MAX) = 12MHz		10.6		

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	COND	ITIONS	MIN	TYP	MAX	UNITS		
		Dynamic, IPO enabled, total current into V _{DD} pin, V _{DD} = 1.8V, CPU in SLEEP mode, ECC disabled, DMA disabled, inputs	OVR = [10], internal regulator set to 1.1V, fsys_clk(MAX) = 100MHz		14.6				
			OVR = [01], internal regulator set to 1.0V, fSYS_CLK(MAX) = 50MHz		11.7				
		tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [00], internal regulator set to 0.9V, fsys_CLK(MAX) = 12MHz		10.5				
		Fixed, IPO enabled, total	OVR = [10], internal regulator set to 1.1V. See <u>Temperature</u> <u>Variance</u>		735				
		current into V _{DD} pin, V _{DD} = 3.3V, CPU in SLEEP mode, ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA Fixed, IPO enabled, total current into V _{DD} pin, V _{DD} = 1.8V, CPU in SLEEP mode, ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	pin, V _{DD} = 3.3V, CPU in SLEEP mode, ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [01], internal regulator set to 1.0V. See <u>Temperature</u> <u>Variance</u>		659			
				outputs source/sink 0mA	OVR = [00], internal regulator set to 0.9V. See <u>Temperature</u> <u>Variance</u>		563		
	IDD_FSLPS		OVR = [10], internal regulator set to 1.1V. See <u>Temperature</u> <u>Variance</u>		754		μΑ		
			pin, V _{DD} = 1.8V, CPU in SLEEP mode, ECC disabled, inputs	pin, V _{DD} = 1.8V, CPU in SLEEP mode, ECC disabled, inputs	OVR = [01], internal regulator set to 1.0V. See <u>Temperature</u> <u>Variance</u>		633		
			OVR = [00], internal regulator set to 0.9V. See <u>Temperature</u> <u>Variance</u>		538				

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	COND	ITIONS	MIN TYP MAX	UNITS	
V _{DD} Fixed Current,	1	Standby state with full data retention	V _{DD} = 3.3V. See <u>Temperature</u> <u>Variance</u>	4.0		
DEEPSLEEP Mode	IDD_FDSLPS	and 160KB SRAM retained	V _{DD} = 1.8V. See <u>Temperature</u> <u>Variance</u>	3.7	– μA	
VDD Fixed Current, BACKUP Mode IDD_FBKUS			OKB SRAM retained, retention regulator disabled. See <u>Temperature</u> <u>Variance</u>	0.38		
		20KB SRAM retained. See <u>Temperature</u> <u>Variance</u>	1.08			
	V _{DD} = 3.3V, RTC disabled	40KB SRAM retained. See <u>Temperature</u> <u>Variance</u>	1.4			
			80KB SRAM retained. See Temperature Variance	1.9		
	las same		160KB SRAM retained. See <u>Temperature</u> <u>Variance</u>	2.8	μΑ	
	רטט_FBKUS	V _{DD} = 1.8V, RTC disabled	OKB SRAM retained, retention regulator disabled. See <i>Temperature Variance</i>	0.15	μΛ	
				20KB SRAM retained. See Temperature Variance	0.86	
			40KB SRAM retained. See <u>Temperature</u> <u>Variance</u>	1.2		
			80KB SRAM retained. See Temperature Variance	1.7		
			160KB SRAM retained. See Temperature Variance	2.58		

High-Reliability, Ultra-Low-Power Microcontroller Powered by Arm Cortex-M4 Processor with FPU for Industrial and IoT

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	CONDITIONS	MIN TYP MAX		UNITS	
V _{DD} Fixed Current,	lpp 50700	V _{DD} = 3.3V. See <u>Temperature Variance</u>		0.3		
STORAGE Mode	IDD_FSTOS	V _{DD} = 1.8V. See <u>Temperature Variance</u>	0.11			μΑ
SLEEP Mode Resume Time	t _{SLP_ONS}			2.1		μs
DEEPSLEEP Mode .	t			89		
Resume Time	tdsl_ons	fast_wk_en = 0	129		μs	
BACKUP Mode Resume Time	t _{BKU_ONS}	Includes system initialization and ROM execution time	1.25		ms	
STORAGE Mode Resume Time	tsto_ons	Includes system initialization and ROM execution time	1.5		ms	

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	COND	ITIONS	MIN	TYP	MAX	UNITS
POWER / DUAL-SUPPLY	Y OPERATION (\	/ _{DD} AND V _{CORE})					
IC		Dynamic, IPO enabled, total current into V _{CORE}	OVR = [10], V _{CORE} = 1.1V, f _{SYS_CLK(MAX)} = 100MHz		56.7		
		pin, CPU in ACTIVE mode, executing CoreMark, ECC disabled, inputs	OVR = [01], V _{CORE} = 1.0V, f _{SYS} CLK(MAX) = 50MHz	:	55.3		
		tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [00], V _{CORE} = 0.9V, f _{SYS} CLK(MAX) = 12MHz		48.9		uA/MHz
	ICORE_DACTD	Dynamic, IPO enabled, total current into V _{CORE} pin, CPU in ACTIVE mode, executing While(1), ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [10], V _{CORE} = 1.1V, f _{SYS} CLK(MAX) = 100MHz		42.2		- μΑνίνιπ2 -
V _{CORE} Current, ACTIVE Mode			OVR = [01], V _{CORE} = 1.0V, f _{SYS} CLK(MAX) = 50MHz		40.5		
I _{CORE_FACTI}			OVR = [00], V _{CORE} = 0.9V, f _{SYS} CLK(MAX) = 12MHz	:	35.7		
		Fixed, IPO enabled, total current into V _{CORE} pin, CPU in ACTIVE mode 0MHz execution, ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [10], V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>		311		
	ICORE_FACTD		OVR = [01], V _{CORE} = 1.0V. See <u>Temperature</u> <u>Variance</u>		209		μА
			OVR = [00], V _{CORE} = 0.9V. See <u>Temperature</u> <u>Variance</u>		106		

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	COND	ITIONS	MIN	TYP	MAX	UNITS
		Dynamic, IPO enabled, total current into V _{DD}	OVR = [10], f _{SYS_CLK(MAX)} = 100MHz		0.449		
		pin, V _{DD} = 3.3V, CPU in ACTIVE mode, executing CoreMark, ECC	OVR = [01], f _{SYS CLK(MAX)} = 50MHz		0.457		
		disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [00], f _{SYS CLK(MAX)} = 12MHz		0.473		
	Dynamic, IPO enabled, total current into V _{DD}	OVR = [10], f _{SYS CLK(MAX)} = 100MHz		0.209			
	pin, V _{DD} = 1.8V, CPU in ACTIVE mode, executing CoreMark, ECC	OVR = [01], f _{SYS CLK(MAX)} = 50MHz		0.214			
V _{DD} Current, ACTIVE	les sucre	disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [00], fsys_clk(MAX) = 12MHz		0.233		- μΑ/MHz
Mode	IDD_DACTD	Dynamic, IPO enabled, total current into V _{DD}	OVR = [10], f _{SYS} CLK(MAX) = 100MHz		0.448	μΑνίνιτιΣ	μΑνίνιι ιΖ
		pin, V _{DD} = 3.3V, CPU in ACTIVE mode, executing	OVR = [01], f _{SYS CLK(MAX)} = 50MHz		0.456		
		While(1), ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [00], fsys_clk(MAX) = 12MHz		0.474		
	Dynamic, IPO enabled, total current into V _{DD}	OVR = [10], f _{SYS_CLK(MAX)} = 100MHz		0.207			
		pin, V _{DD} = 1.8V, CPU in ACTIVE mode, executing	OVR = [01], f _{SYS_CLK(MAX)} = 50MHz		0.214		
		While(1), ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [00], fsys clk(MAX) = 12MHz		0.226		

High-Reliability, Ultra-Low-Power Microcontroller Powered by Arm Cortex-M4 Processor with FPU for Industrial and IoT

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	COND	ITIONS	MIN	TYP	MAX	UNITS
		Fixed, IPO enabled, total current into V _{DD} pin, V _{DD} = 3.3V, CPU in ACTIVE mode 0MHz execution, ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [10], V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>		391		
			OVR = [01], V _{CORE} = 1.0V. See <u>Temperature</u> <u>Variance</u>		390		
			OVR = [00], V _{CORE} = 0.9V. See <u>Temperature</u> <u>Variance</u>		387		
		Fixed, IPO enabled, total current into V _{DD} pin, V _{DD} = 1.8V, CPU in ACTIVE mode 0MHz execution, ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [10], V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>		372		μА
			OVR = [01], V _{CORE} = 1.0V. See <u>Temperature</u> <u>Variance</u>		372		
			OVR = [00], V _{CORE} = 0.9V. See <u>Temperature</u> <u>Variance</u>		369		

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	COND	ITIONS	MIN	TYP	MAX	UNITS
		Dynamic, IPO enabled, total current into V _{CORE}	OVR = [10], V _{CORE} = 1.1V, f _{SYS_CLK(MAX)} = 100MHz		29.8		
		pin, CPU in SLEEP mode, ECC disabled, standard DMA with two channels active.	OVR = [01], V _{CORE} = 1.0V, f _{SYS} CLK(MAX) = 50MHz		28.7		
		inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [00], V _{CORE} = 0.9V, f _{SYS} CLK(MAX) = 12MHz		26.3		μΑ/MHz
	CORE_DSLPD	Dynamic, IPO enabled, total current into V _{CORE} pin, CPU in SLEEP mode, ECC disabled, DMA disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [10], V _{CORE} = 1.1V, f _{SYS} CLK(MAX) = 100MHz		13.0		μενινιι ιΖ
V _{CORE} Current, SLEEP Mode			OVR = [01], V _{CORE} = 1.0V, f _{SYS} CLK(MAX) = 50MHz		11.7		
			OVR = [00], V _{CORE} = 0.9V, f _{SYS} CLK(MAX) = 12MHz		9.0		
I _{COR}		Fixed, IPO enabled, total	OVR [10], V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>		311		
	ICORE_FSLPD	ICORE_FSLPD current into VCORE pin, CPU in SLEEP mode, ECC disabled, inputs tied to VS or VDD, outputs source/sink 0mA	OVR [01], V _{CORE} = 1.0V. See <u>Temperature</u> <u>Variance</u>		209		μА
			OVR [00], V _{CORE} = 0.9V. See <u>Temperature</u> <u>Variance</u>		106		

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	COND	ITIONS	MIN TYP MAX	UNITS
		Dynamic, IPO enabled, total current into V _{DD} pin, V _{DD} = 3.3V,	OVR = [10], V _{CORE} = 1.1V, f _{SYS} CLK(MAX) = 100MHz	0.001	
		CPU in SLEEP mode, ECC disabled, standard	OVR = [01], V _{CORE} = 1.0V, f _{SYS} CLK(MAX) = 50MHz	0.001	
V _{DD} Current, SLEEP		channels active, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [00], V _{CORE} = 0.9V, f _{SYS} CLK(MAX) = 12MHz	0.001	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \
	IDD_DSLPD	Dynamic, IPO enabled, total current into V _{DD} pin, V _{DD} = 1.8V,	OVR = [10], V _{CORE} = 1.1V, f _{SYS} CLK(MAX) = 100MHz	0.001	μA/MHz
		CPU in SLEEP mode, ECC disabled, standard DMA with two channels active, inputs tied to V _{SS} or V _{SD} outputs	OVR = [01], V _{CORE} = 1.0V, f _{SYS} CLK(MAX) = 50MHz	0.001	
			OVR = [00], V _{CORE} = 0.9V, f _{SYS} CLK(MAX) = 12MHz	0.001	
Mode	IDD_FSLPD	Fixed, IPO enabled, total current into V_{DD} pin, $V_{DD} = 3.3V$, CPU in SLEEP mode, ECC disabled, inputs tied to V_{SS} or V_{DD} , outputs source/sink 0mA	OVR = [10], V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	391	
			OVR = [01], V _{CORE} = 1.0V. See <u>Temperature</u> <u>Variance</u>	390	
IDD			OVR = [00], V _{CORE} = 0.9V. See <u>Temperature</u> <u>Variance</u>	387	
		Fixed, IPO enabled, total current into V _{DD}	OVR = [10], V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	372	– μA
		pin, V _{DD} = 1.8V, CPU in SLEEP mode, ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [01], V _{CORE} = 1.0V. See <u>Temperature</u> <u>Variance</u>	372	
			OVR = [00], V _{CORE} = 0.9V. See <u>Temperature</u> <u>Variance</u>	369	

High-Reliability, Ultra-Low-Power Microcontroller Powered by Arm Cortex-M4 Processor with FPU for Industrial and IoT

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
		V _{DD} = 3.3V, V _{CORE} = 1.1V. See <u>Temperature Variance</u>	10.5			
V _{CORE} Fixed Current, DEEPSLEEP Mode	ICORE FDSLP	V _{DD} = 3.3V, V _{CORE} = 0.855V. See <u>Temperature Variance</u>		4		
	D	V _{DD} = 1.8V, V _{CORE} = 1.1V. See <u>Temperature Variance</u>	10.5		μΑ	
		V _{DD} = 1.8V, V _{CORE} = 0.855V. See <u>Temperature Variance</u>	4			
		V _{DD} = 3.3V, V _{CORE} = 1.1V. See <u>Temperature Variance</u>	0.36			
V _{DD} Fixed Current, DEEPSLEEP Mode		V _{DD} = 3.3V, V _{CORE} = 0.855V. See <u>Temperature Variance</u>	0.36		μA	
	IDD_FDSLPD	V _{DD} = 1.8V, V _{CORE} = 1.1V. See <u>Temperature Variance</u>	0.149		μΛ	
		V _{DD} = 1.8V, V _{CORE} = 0.855V. See <u>Temperature Variance</u>		0.149		

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	COND	ITIONS	MIN TYP	MAX	UNITS
			V _{DD} = 3.3V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	0.3		
		0KB SRAM retained, RTC	V _{DD} = 3.3V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>	0.19		
		disabled, retention regulator disabled	V _{DD} = 1.8V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	0.297		
		V _{DD} = 1.8V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>	0.187			
		V _{DD} = 3.3V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	1.37			
V _{CORE} Fixed Current,	ICORE FBKUD	20KB SRAM retained with RTC disabled	V _{DD} = 3.3V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>	0.6		- μΑ
BACKUP Mode	COKE_FBK0D		V _{DD} = 1.8V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	1.37		μ/.
			V _{DD} = 1.8V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>	0.6		
			V _{DD} = 3.3V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	2.39		
	40KB SRAM retained with RTC	V _{DD} = 3.3V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>	0.99			
		disabled	V _{DD} = 1.8V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	2.39		
			V _{DD} = 1.8V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>	0.99		

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	COND	OITIONS	MIN	ТҮР	MAX	UNITS
			V _{DD} = 3.3V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	4	4.15		
		80KB SRAM retained with RTC	V _{DD} = 3.3V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>		1.6		
		disabled	V _{DD} = 1.8V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	4	4.15		
			V _{DD} = 1.8V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>		1.6		
			V _{DD} = 3.3V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>		7.4		
		160KB SRAM	V _{DD} = 3.3V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>		2.7		
		retained with RTC disabled	V _{DD} = 1.8V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>		7.4		
			V _{DD} = 1.8V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>		2.7		

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	COND	ITIONS	MIN TYP	MAX	UNITS
			V _{DD} = 3.3V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	0.36		
		0KB SRAM retained with RTC	V _{DD} = 3.3V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>	0.36		
V _{DD} Fixed Current,		disabled, retention regulator disabled	V _{DD} = 1.8V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	0.15		
		V _{DD} = 1.8V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>	0.15			
		V _{DD} = 3.3V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	0.36			
	loo sovio	20KB SRAM retained with RTC disabled	V _{DD} = 3.3V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>	0.36		- μΑ
BACKUP Mode	IDD_FBKUD		V _{DD} = 1.8V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	0.15		μ/.
			V _{DD} = 1.8V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>	0.15		
			V _{DD} = 3.3V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	0.36		
	40KB SRAM retained with RTC	V _{DD} = 3.3V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>	0.36			
		disabled	V _{DD} = 1.8V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>	0.15		
			V _{DD} = 1.8V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>	0.15		

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	COND	ITIONS	MIN	TYP	MAX	UNITS
			V _{DD} = 3.3V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>		0.36		
		80KB SRAM retained with RTC	V _{DD} = 3.3V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>		0.36		
		disabled	V _{DD} = 1.8V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>		0.15		
			V _{DD} = 1.8V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>		0.15		
		160KB SRAM retained with RTC disabled	V _{DD} = 3.3V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>		0.36		
			V _{DD} = 3.3V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>		0.36		
			V _{DD} = 1.8V, V _{CORE} = 1.1V. See <u>Temperature</u> <u>Variance</u>		0.15		
			V _{DD} = 1.8V, V _{CORE} = 0.855V. See <u>Temperature</u> <u>Variance</u>		0.15		
		V _{DD} = 3.3V, V _{CORE} <u>Temperature Varian</u>			0.25		
V _{CORE} Fixed Current,	ixed Current, E Mode	V _{DD} = 3.3V, V _{CORE} <u>Temperature Varian</u>			0.14] .
STORAGE Mode		V _{DD} = 1.8V, V _{CORE} Temperature Varian			0.25		μΑ
		V _{DD} = 1.8V, V _{CORE} Temperature Varian			0.14		

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	
		V _{DD} = 3.3V; V _{CORE} = 1.1V. See <u>Temperature Variance</u>		0.32			
V _{DD} Fixed Current,	I _{DD_FSTOD}	V _{DD} = 3.3V; V _{CORE} = 0.855V. See <u>Temperature Variance</u>		0.31			
STORAGE Mode		V _{DD} = 1.8V; V _{CORE} = 1.1V. See <u>Temperature Variance</u>		0.11		μA	
		V _{DD} = 1.8V; V _{CORE} = 0.855V. See <u>Temperature Variance</u>		0.11			
SLEEP Mode Resume Time	t _{SLP_OND}			2.1		μs	
DEEPSLEEP Mode	t	fast_wk_en = 1		81			
Resume Time	t _{DSL_OND}	fast_wk_en = 0		129		μs	
BACKUP Mode Resume Time	tBKU_OND	Includes system initialization and ROM execution time		1.25		ms	
STORAGE Mode Resume Time	tsto_ond	Includes system initialization and ROM execution time		1.5		ms	
GENERAL-PURPOSE I/O	1					•	
Input Low Voltage for All GPIO, RSTN	V _{IL_GPIO}	Pin configured as GPIO			0.3 × V _{DD}	V	
Input High Voltage for All GPIO, RSTN	V _{IH_GPIO}	Pin configured as GPIO	0.7 × V _{DD}			V	
	Vol_gpio	V _{DD} = 1.71V, I _{OL} = 1mA, DS[1:0] = 00 (Note 1)		0.2	0.4		
Output Low Voltage for All GPIO Except P0.6,		V _{DD} = 1.71V, I _{OL} = 2mA, DS[1:0] = 10 (Note 1)		0.2	0.4	V	
P0.7, P0.12, P0.13, P0.18, and P0.19		V _{DD} = 1.71V, I _{OL} = 4mA, DS[1:0] = 01 (Note 1)		0.2	0.4		
		V _{DD} = 1.71V, I _{OL} = 6mA, DS[1:0] = 11 (Note 1)		0.2	0.4		
Output Low Voltage for		V _{DD} = 1.71V, I _{OL} = 2mA, DS = 0 (Note 1)		0.2	0.4		
GPIO P0.6, P0.7, P0.12, P0.13, P0.18, and P0.19	V _{OL_I2C}	V _{DD} = 1.71V, I _{OL} = 10mA, DS = 1 (Note 1)		0.2	0.4	V	
		V _{DD} = 1.71V, I _{OH} = 1mA, DS[1:0] = 00 (Note 1)	V _{DD} - 0.4				
Output High Voltage for All GPIO Except P0.6,	V	V _{DD} = 1.71V, I _{OH} = 2mA, DS[1:0] = 10 (Note 1)	V _{DD} - 0.4			V	
P0.7, P0.12, P0.13, P0.18, and P0.19	V _{OH_GPIO}	V _{DD} = 1.71V, I _{OH} = 4mA, DS[1:0] = 01 (Note 1)	V _{DD} - 0.4			V	
		V _{DD} = 1.71V, I _{OH} = 6mA, DS[1:0] = 11 (Note 1)	V _{DD} - 0.4				
Output High Voltage for		V _{DD} = 1.71V, I _{OH} = 2mA, DS = 0 (Note 1)	V _{DD} - 0.4			V	
PIO P0.6, P0.7, P0.12, 0.13, P0.18, and P0.19	VOH_I2C	V _{DD} = 1.71V, I _{OH} = 10mA, DS = 1 (Note 1)	V _{DD} - 0.4			\ \ \	

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Combined I _{OL} , All GPIO	I _{OL_TOTAL}				100	mA
Combined I _{OH} , All GPIO	I _{OH_TOTAL}		-100			mA
Input Hysteresis (Schmitt)	V _{IHYS}			300		mV
Input/Output Pin Capacitance for All Pins	C _{IO}			4		pF
Input Leakage Current Low	I _{IL}	V _{IN} = 0V, internal pull-up disabled	-500		+500	nA
Input Leakage Current High	I _{IH}	V _{IN} = 3.6V, internal pull-down disabled	-500		+500	nA
Input Pull-Up Resistor to	Pour von	Pull up to $V_{DD} = V_{RST}$, RSTN at V_{IH}		18.7		kΩ
RSTN	R _{PU_VDD}	Pull up to V_{DD} = 3.63V, RSTN at V_{IH} 10.0				K22
Input Pull-Up Resistor	R _{PU}	Device pin configured as GPIO, pull up to V_{DD} = V_{RST} , device pin at V_{IH}		18.7		kΩ
for All GPIO	O I	Device pin configured as GPIO, pull up to V_{DD} = 3.63V, device pin at V_{IH}		10.0		K\$2
Input Pull-Down	D	Device pin configured as GPIO, pull down to V _{SS} , V _{DD} = V _{RST} , device pin at V _{IL}		17.6		kΩ
Resistor for All GPIO	R _{PD}	Device pin configured as GPIO, pull down to V _{SS} , V _{DD} = 3.63V, device pin at V _{IL}	8.8		K12	
CLOCKS						
System Clock Frequency	fsys_clk				100	MHz
System Clock Period	tsys_clk			1/f _{SYS_C} LK		μѕ
Internal Primary Oscillator (IPO)	f _{IPO}	Default OVR = [10]		100		MHz
External RF Oscillator (XRFO)	f _{XRFO}	Required crystal characteristics: C_L = 12pF, ESR \leq 50 Ω , $C_0 \leq$ 7pF, temperature stability \pm 20ppm, initial tolerance \pm 20ppm	16		32	MHz
Internal Baud Rate Oscillator (IBRO)	f _{IBRO}			7.3728		MHz
Internal Nano-Ring Oscillator (INRO)	fINRO	Measured at V _{DD} = 1.8V		70		kHz
External RTC Oscillator (XRTCO)	fxrtco	32.768kHz watch crystal, C_L = 6pF, ESR < 90kΩ, C_0 < 2pF		32.768		kHz
RTC Operating Current	I _{RTC}	All power modes, RTC enabled		0.35		μA
RTC Power-Up Time	t _{RTC_} ON			250		ms
External Clock Input Frequency		EXT_CLK1 selected	50			
	fevrous	EXT_CLK2 selected			1	MHz

Electrical Characteristics (continued)

(Limits are 100% tested at T_A = +25°C and T_A = +105°C. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Specifications marked GBD are guaranteed by design and not production tested. Specifications to the minimum operating temperature are guaranteed by design and are not production tested.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	
FLASH MEMORY							
Flash Erase Time	t _{M_ERASE}	Mass erase		30		ma	
Flash Erase Time	tp_ERASE	Page erase	30			ms	
Flash Programming Time per Word	t _{PROG}	32-bit programming mode, f _{FLC_CLK} = 1MHz	42			μs	
Flash Endurance			10			kcycles	
Data Retention	t _{RET}	T _A = +125°C	10			years	

Electrical Characteristics—SPI

(Timing specifications are guaranteed by design and not production tested.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
MASTER MODE			'			1
SPI Master Operating Frequency	f _{MCK}	f _{SYS_CLK} = 100MHz, f _{MCK(MAX)} = f _{SYS_CLK} /2			50	MHz
SPI Master SCK Period	t _{MCK}			1/f _{MCK}		ns
SCK Output Pulse- Width High/Low	t _{MCH} , t _{MCL}		t _{MCK} /2			ns
MOSI Output Hold Time After SCK Sample Edge	tмон		t _{MCK} /2			ns
MOSI Output Valid to Sample Edge	t _{MOV}		t _{MCK} /2			ns
MOSI Output Hold Time After SCK Low Idle	t _{MLH}			t _{MCK} /2		ns
MISO Input Valid to SCK Sample Edge Setup	t _{MIS}			5		ns
MISO Input to SCK Sample Edge Hold	t _{MIH}			t _{MCK} /2		ns
SLAVE MODE			·			
SPI Slave Operating Frequency	fsck				50	MHz
SPI Slave SCK Period	t _{SCK}			1/f _{SCK}		ns
SCK Input Pulse-Width High/Low	t _{SCH} , t _{SCL}			t _{SCK} /2		ns
SSx Active to First Shift Edge	t _{SSE}			10		ns
MOSI Input to SCK Sample Edge Rise/Fall Setup	tsis			5		ns
MOSI Input from SCK Sample Edge Transition Hold	tsiH			1		ns

Electrical Characteristics—SPI (continued)

(Timing specifications are guaranteed by design and not production tested.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
MISO Output Valid After SCLK Shift Edge Transition	t _{SOV}			5		ns
SCK Inactive to SSx Inactive	tssp			10		ns
SSx Inactive Time	tssh			1/f _{SCK}		μs
MISO Hold Time After SSx Deassertion	t _{SLH}			10		ns

Electrical Characteristics—I²C

(Timing specifications are guaranteed by design and not production tested.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
STANDARD-MODE			'			
Output Fall Time	t _{OF}	Standard mode, from V _{IH(MIN)} to V _{IL(MAX)}		150		ns
SCL Clock Frequency	f_{SCL}		0		100	kHz
Low Period SCL Clock	t_{LOW}		4.7			μs
High Time SCL Clock	tHIGH		4.0			μs
Setup Time for Repeated Start Condition	tsu;sta		4.7			μs
Hold Time for Repeated Start Condition	t _{HD;STA}		4.0			μs
Data Setup Time	t _{SU;DAT}			300		ns
Data Hold Time	t _{HD;DAT}			10		ns
Rise Time for SDA and SCL	t _R			800		ns
Fall Time for SDA and SCL	t _F			200		ns
Setup Time for a Stop Condition	tsu;sto		4.0			μs
Bus Free Time Between a Stop and Start Condition	t _{BUS}		4.7			μs
Data Valid Time	t _{VD;DAT}		3.45			μs
Data Valid Acknowledge Time	t _{VD;ACK}		3.45			μs
FAST-MODE			·			
Output Fall Time	t _{OF}	From V _{IH(MIN)} to V _{IL(MAX)}		150		ns
Pulse Width Suppressed by Input Filter	t _{SP}			75		ns
SCL Clock Frequency	f _{SCL}		0		400	kHz
Low Period SCL Clock	t _{LOW}		1.3			μs

Electrical Characteristics—I²C (continued)

(Timing specifications are guaranteed by design and not production tested.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
High Time SCL Clock	^t HIGH		0.6			μs
Setup Time for Repeated Start Condition	t _{SU;STA}		0.6			μs
Hold Time for Repeated Start Condition	t _{HD;STA}		0.6			μs
Data Setup Time	t _{SU;DAT}			125		ns
Data Hold Time	t _{HD;DAT}			10		ns
Rise Time for SDA and SCL	t_{R}			30		ns
Fall Time for SDA and SCL	t _F			30		ns
Setup Time for a Stop Condition	t _{SU;STO}		0.6			μs
Bus Free Time Between a Stop and Start Condition	t _{BUS}		1.3			μs
Data Valid Time	t _{VD;DAT}		0.9			μs
Data Valid Acknowledge Time	t _{VD;ACK}		0.9			μs
FAST-MODE PLUS						
Output Fall Time	t _{OF}	From V _{IH(MIN)} to V _{IL(MAX)}		80		ns
Pulse Width Suppressed by Input Filter	t _{SP}			75		ns
SCL Clock Frequency	f _{SCL}		0		1000	kHz
Low Period SCL Clock	t _{LOW}		0.5			μs
High Time SCL Clock	^t HIGH		0.26			μs
Setup Time for Repeated Start Condition	t _{SU;STA}		0.26			μs
Hold Time for Repeated Start Condition	t _{HD;STA}		0.26			μs
Data Setup Time	tsu;dat			50		ns
Data Hold Time	t _{HD;DAT}			10		ns
Rise Time for SDA and SCL	t_{R}			50		ns
Fall Time for SDA and SCL	t _F			30		ns
Setup Time for a Stop Condition	t _{SU;STO}		0.26			μs
Bus Free Time Between a Stop and Start Condition	t _{BUS}		0.5			μs
Data Valid Time	t _{VD;DAT}		0.45			μs

Electrical Characteristics—I²C (continued)

(Timing specifications are guaranteed by design and not production tested.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Data Valid Acknowledge Time	^t VD;ACK		0.45			μs

Electrical Characteristics—I²S Slave

(Timing specifications are guaranteed by design and not production tested.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Bit Clock Frequency	f _{BCLK}	96kHz LRCLK frequency			3.072	MHz
BCLK High Time	twbclkh			0.5		1/f _{BCLK}
BCLK Low Time				0.5		1/f _{BCLK}
LRCLK Setup Time	tLRCLK_BLCK			25		ns
Delay Time, BCLK to SD (Output) Valid	tBCLK_SDO			12		ns
Setup Time for SD (Input)	tsu_sdi			6		ns
Hold Time SD (Input)	t _{HD_SDI}			3		ns

GPIO Drive Strength: Note 1: When using a GPIO bias voltage of 2.97V, the drive current capability of the GPIO is 2x that of its drive strength when using a GPIO bias voltage of 1.71V.

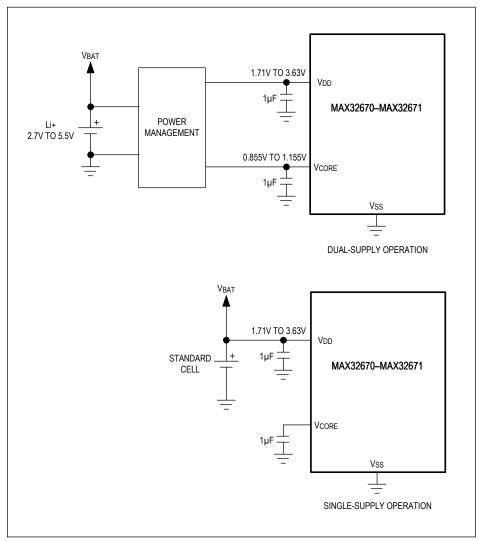


Figure 1. Power-Supply Operational Modes

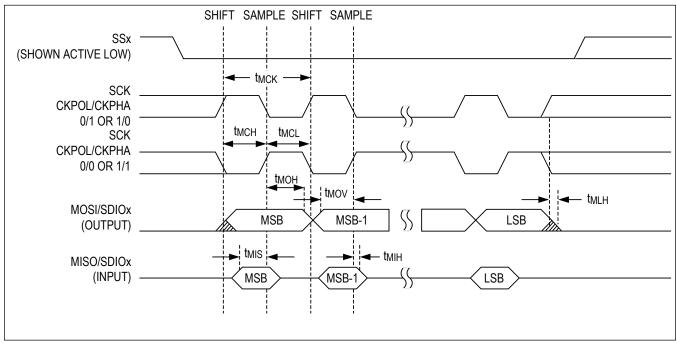


Figure 2. SPI Master Mode Timing Diagram

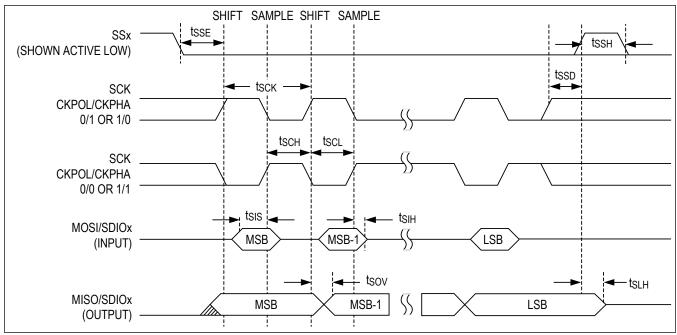


Figure 3. SPI Slave Mode Timing Diagram

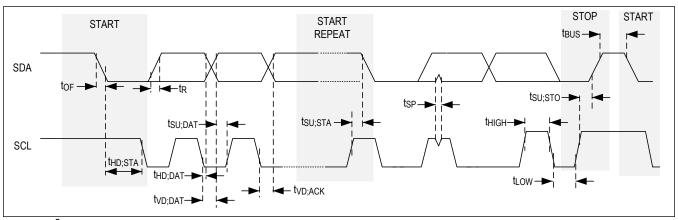


Figure 4. I²C Timing Diagram

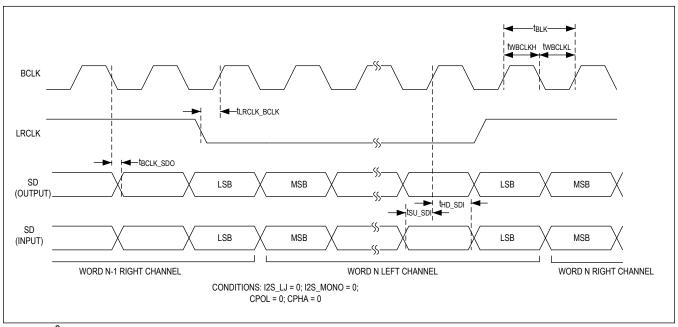
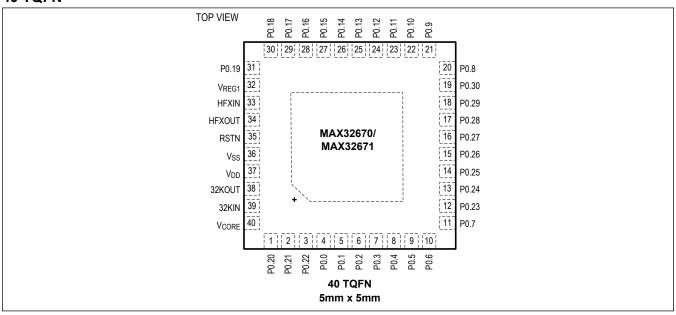


Figure 5. I²S Timing Diagram

Pin Configuration

40 TQFN



Pin Description

			Fl	JNCTION MOD	DE							
PIN	NAME	Primary Signal (Default)	Alternate Function 1	Alternate Function 2	Alternate Function 3	Alternate Function 4	FUNCTION					
POWE	POWER (See the <u>Applications Information</u> section for bypass capacitor recommendations.)											
40	V _{CORE}	_	_	_	_	_	Digital Power-Supply Input. Bypass with 100nF to V_{SS} and 1 μ F with 10m Ω to 150m Ω ESR to V_{SS} .					
32	V _{REG1}	_	_		_	_	Bypass with 4.7nF to V _{SS} . Do not connect this device pin to any other external circuitry.					
37	V _{DD}	_	_	_	_	_	Power-Supply Input. Bypass with 100nF to V_{SS} and $1\mu F$ with $10m\Omega$ to $150m\Omega$ ESR to V_{SS} .					
36	V_{SS}	_	_	_	_	_	Digital Ground					
RESET	AND CONT	ROL										
35	RSTN	_	_	_	_	_	Active-Low, External System Reset Input. The device remains in reset while this pin is in its active state. When the pin transitions to its inactive state, the device performs a POR reset (resetting all logic on all supplies except for real-time clock circuitry) and begins execution. This pin has an internal pull-up to the VDD supply.					

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40 TQFN

			Fl	JNCTION MOI	DE		
PIN	NAME	Primary Signal (Default)	Alternate Function 1	Alternate Function 2	Alternate Function 3	Alternate Function 4	FUNCTION
CLOCI	K		•	1			
38	32KOUT	_	_	_	_	_	32kHz Crystal Oscillator Output. Refer to the <u>MAX32670/MAX32671</u> <u>User Guide</u> for determination of the required external stability capacitors.
39	32KIN	_	_	_	_	_	32kHz Crystal Oscillator Input. Connect a 32kHz crystal between 32KIN and 32KOUT for RTC operation. Refer to the MAX32670/ MAX32671 User Guide for determination of the required external stability capacitors. Optionally, this pin can be configured as the input for an external CMOS- level clock source.
33	HFXIN	_	_	_	_	_	RF Crystal Oscillator Input. Connect the crystal between HFXIN and HFXOUT. Optionally, this pin can be configured as the input for an external square-wave source. See the <i>Electrical Characteristics</i> table for details of the crystal requirements.
34	HFXOUT	_	_	_	_	_	RF Crystal Oscillator Output. Connect the crystal between HFXIN and HFXOUT. See the Electrical Characteristics table for details of the crystal requirements.
GPIO A	AND ALTERI	NATE FUNCT	ON (See the A	Applications In	<u>formation</u> sec	tion for GPIO	and Alternate Function Matrices.)
4	P0.0	P0.0	SWDIO	_	TMR0C_IA	_	Single-Wire Debug I/O; Timer0 Port Map C Input.
5	P0.1	P0.1	SWDCLK	_	TMR0C_O	_	Single-Wire Debug Clock; Timer0 Port Map C Output. This device pin also controls the behavior of the device when exiting a reset event. See <u>Applications Information</u> for details.
6	P0.2	P0.2	SPI0_MISO	UART1B_R X	TMR1C_IA	_	SPI0 Master In Slave Out; UART1 Port Map B Rx; Timer1 Port Map C Input
7	P0.3	P0.3	SPI0_MOSI	UART1B_T X	TMR1C_OA	_	SPI0 Master Out Slave In; UART1 Port Map B Tx; Timer1 Port Map C Output
8	P0.4	P0.4	SPI0_SCK	UART1B_C TS	TMR2C_IA	_	SPI0 Serial Clock; UART1 Port Map B CTS; Timer2 Port Map C Input
9	P0.5	P0.5	SPI0_SS0	UART1B_R TS	TMR2C_OA	DIV_CLK_ OUTA	SPI0 Slave Select 0; UART1 Port Map B RTS; Timer2 Port Map C Output; Divided Clock Output Port Map A

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40 TQFN

			Fl	JNCTION MOD	DE		
PIN	NAME	Primary Signal (Default)	Alternate Function 1	Alternate Function 2	Alternate Function 3	Alternate Function 4	FUNCTION
10	P0.6	P0.6	I2C0_SCL	LPTMR0B_I A	TMR3C_IA	_	I2C0 Serial Clock; Low-Power Timer0 Port Map B Input; Timer3 Port Map C Input
11	P0.7	P0.7	I2C0_SDA	LPTMR0B_ OA	TMR3C_OA	_	I2C0 Serial Data; Low-Power Timer0 Port Map B Output; Timer3 Port Map C Output
20	P0.8	P0.8	UART0A_R X	12S0_SDO	TMR0C_IA	П	UART0 Port Map A Rx; I2S0 Serial Data Output; Timer0 Port Map C Input. This device pin also controls the behavior of the device when exiting a reset event. See Applications Information for details.
21	P0.9	P0.9	UART0A_T X	I2S0_LRCL K	TMR0C_OA	ı	UART0 Port Map A Tx; I2S0 Left/ Right Clock; Timer0 Port Map C Output
22	P0.10	P0.10	UART0A_C TS	I2S0_BCLK	TMR1C_IA	DIV_CLK_ OUTB	UART0 Port Map A CTS; I2S0 Bit Clock; Timer1 Port Map C Input; Divided Clock Output Port Map B
23	P0.11	P0.11	UART0A_R TS	12S0_SDI	TMR1C_OA		UART0 Port Map A RTS; I2S0 Serial Data Input; Timer1 Port Map C Output
24	P0.12	P0.12	I2C1_SCL	EXT_CLK2	TMR2C_IA	EXT_CLK1	I2C1 Serial Clock; Low-Power External Clock Input; Timer2 Port Map C Input; External Clock Input
25	P0.13	P0.13	I2C1_SDA	32KCAL	TMR2C_OA	SPI1_SS0	I2C1 Serial Data; 32.768kHz Calibration Output; Timer2 Port Map C Output; SPI1 Slave Select 0
26	P0.14	P0.14	SPI1_MISO	UART2B_R X	TMR3C_IA	_	SPI1 Master In Slave Out; UART2 Port Map B Rx; Timer3 Port Map C Input
27	P0.15	P0.15	SPI1_MOSI	UART2B_T X	TMR3C_OA	-	SPI1 Master Out Slave In; UART2 Port Map B Tx; Timer3 Port Map C Output
28	P0.16	P0.16	SPI1_SCK	UART2B_C TS	TMR0C_IA	_	SPI1 Serial Clock; UART2 Port Map B CTS; Timer0 Port Map C Input
29	P0.17	P0.17	SPI1_SS0	UART2B_R TS	TMR0C_OA	-	SPI1 Slave Select 0; UART2 Port Map B RTS; Timer0 Port Map C Output
30	P0.18	P0.18	I2C2_SCL	_	TMR1C_IA	_	I2C2 Serial Clock; Timer1 Port Map C Input
31	P0.19	P0.19	I2C2_SDA	_	TMR1C_OA	_	I2C2 Serial Data; Timer1 Port Map C Output
1	P0.20	P0.20	CM4_RX	_	TMR2C_IA	SWDCLKB	CM4 Rx Event Input; Timer2 Port Map C Input; Single-Wire Debug Clock Port Map B
2	P0.21	P0.21	CM4_TX	_	TMR2C_OA	_	CM4 Tx Event Output; Timer2 Port Map C Output

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40 TQFN

			Fl	JNCTION MOD	DE					
PIN	NAME	Primary Signal (Default)	Alternate Function 1	Alternate Function 2	Alternate Function 3	Alternate Function 4	FUNCTION			
3	P0.22	P0.22	LPTMR1A_I A	_	TMR3C_IA	SWDIOB	Low-Power Timer1 Port Map A Input; Timer3 Port Map C Input; Single- Wire Debug Port Map B I/O			
12	P0.23	P0.23	LPTMR1A_ OA		TMR3C_OA	ı	Low-Power Timer1 Port Map A Output; Timer3 Port Map C Output			
13	P0.24	P0.24	LPUART0_ CTS	UART0B_R X	TMR0C_IA	_	Low-Power UART0 CTS; UART0 Port Map B Rx; Timer0 Port Map C Input			
14	P0.25	P0.25	LPUART0_ RTS	UART0B_T X	TMR0C_OA	_	Low-Power UART0 RTS; UART0 Port Map B Tx; Timer0 Port Map C Output			
15	P0.26	P0.26	LPUART0_ RX	UART0B_C TS	TMR1C_IA	١	Low-Power UART0 Rx; UART0 Port Map B CTS; Timer1 Port Map C Input			
16	P0.27	P0.27	LPUART0_ TX	UART0B_R TS	TMR1C_OA	_	Low-Power UART0 Tx; UART0 Port Map B RTS; Timer1 Port Map C Output			
17	P0.28	P0.28	UART1A_R X		TMR2C_IA		UART1 Port Map A Rx; Timer2 Port Map C Input			
18	P0.29	P0.29	UART1A_T X		TMR2C_OA		UART1 Port Map A Tx; Timer2 Port Map C Output			
19	P0.30	P0.30	UART1A_C TS	_	TMR3C_IA	_	UART1 Port Map A CTS; Timer3 Port Map C Input			

Detailed Description

The MAX32670/MAX32671 are ultra-low-power, cost-effective, high-reliability 32-bit microcontrollers enabling designs with complex sensor processing without compromising battery life. They combine a flexible and versatile power management unit with the powerful Arm Cortex-M4 processor with FPU. They also offer legacy designs an easy and cost optimal upgrade path from 8- or 16-bit microcontrollers. ECC (capable of SEC-DED) for both flash and SRAM provides extremely reliable code execution. The devices integrate up to 384KB of flash memory and 160KB (128KB with ECC) of SRAM to accommodate application and sensor code.

The devices feature five powerful and flexible power modes. They can operate from a single-supply battery or a dual-supply typically provided by a PMIC. The I²C ports support standard-mode, fast-mode, fast-mode plus, and high-speed mode, operating up to 3400kbps. The SPI ports can run up to 50MHz in both master and slave mode, and three UARTs can run up to 4000kBd. One low-power UART can run up to 1000kBd. Four general-purpose 32-bit timers, two low-power 32-bit timers, two windowed watchdog timers, and a real-time clock (RTC) are also provided. An I²S interface provides digital audio streaming to a codec.

Arm Cortex-M4 Processor with FPU Engine

The Arm Cortex-M4 processor with FPU combines high-efficiency signal processing functionality with low power, low cost, and ease of use.

The Arm Cortex-M4 processor with FPU supports single instruction multiple data (SIMD) path DSP extensions, providing:

- Four parallel 8-bit add/sub
- Floating point single precision
- Two parallel 16-bit add/sub
- Two parallel MACs
- 32- or 64-bit accumulate
- Signed or unsigned data, with or without saturation

Memory

Internal Flash Memory

384KB of internal flash memory with error correction provides nonvolatile storage of program and data memory.

Internal SRAM

The internal 160KB SRAM provides low-power retention of application information in all power modes except STORAGE. For enhanced system reliability, the SRAM can be configured as 128KB with ECC SEC-DED. The SRAM can be divided into granular banks that create a flexible SRAM retention architecture. This data-retention feature is optional and configurable. This granularity allows the application to minimize its power consumption by only retaining the most essential data.

Clocking Scheme

Multiple clock sources can be selected as the system clock:

- Internal primary oscillator (IPO) at a nominal frequency of 100MHz
- Internal nanoring oscillator at 80kHz
- External RTC oscillator at 32.768kHz (ERTCO) (external crystal required)
- Internal baud rate oscillator at 7.3728MHz (IBRO)
- External RF oscillator at 16MHz to 32MHz (ERFO) (external crystal required)
- External square-wave clock up to 50MHz
- External square-wave clock up to 1MHz for LPTMR0, LPTMR1, and LPUART

An external 32.768kHz time base is required when using the RTC.

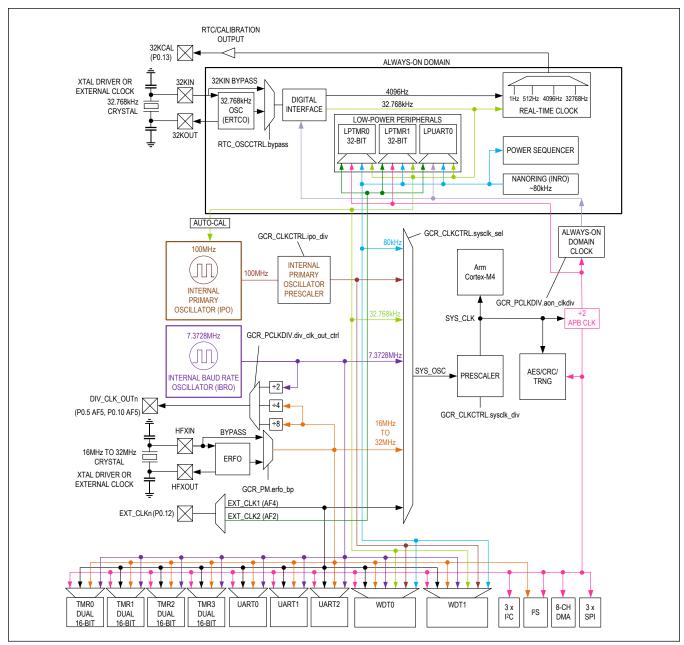


Figure 6. Clocking Scheme

General-Purpose I/O and Special Function Pins

Most general-purpose I/O (GPIO) pins share both a firmware-controlled I/O function and one or more special function signals associated with peripheral modules. Pins can be individually enabled for GPIO or peripheral special function use. Configuring a pin as a special function usually supersedes its use as a firmware-controlled I/O. Though this multiplexing between peripheral and GPIO functions is usually static, it can also be done dynamically. The electrical characteristics of a GPIO pin are identical whether the pin is configured as an I/O or special function, except where explicitly noted in the <u>Electrical Characteristics</u> tables.

In GPIO mode, each pin of a port has an interrupt function that can be independently enabled and configured as a level-

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or edge-sensitive interrupt. All GPIOs share the same interrupt vector. Some packages do not have all of the GPIOs available.

When configured as GPIOs, the following features are provided. These features can be independently enabled or disabled on a per-pin basis.

- Configurable as input, output, bidirectional, or high-impedance
- Optional internal pull-up resistor or internal pull-down resistor when configured as input
- Exit from low-power modes on rising or falling edge
- Selectable standard- or high-drive modes

The MAX32670/MAX32671 provide up to 31 GPIOs for the 40-pin TQFN.

Standard DMA Controller

The standard direct memory access (DMA) controller provides a means to offload the CPU for memory/peripheral data transfer leading to a more power-efficient system. It allows automatic one-way data transfer between two entities. These entities can be either memories or peripherals. The transfers are done without using CPU resources. The following transfer modes are supported:

- 8 channel
- · Peripheral to data memory
- Data memory to peripheral
- Data memory to data memory
- Event support

All DMA transactions consist of an AHB burst read into the DMA FIFO followed immediately by an AHB burst write from the FIFO.

Power Management

Power Management Unit

The power management unit (PMU) provides the optimal mix of high-performance and low-power consumption. It exercises intelligent, precise control of power distribution to the CPU and peripheral circuitry.

The PMU provides the following features:

- User-configurable system clock
- Automatic enabling and disabling of crystal oscillators based on power mode
- Multiple clock domains
- Fast wakeup of powered-down peripherals when activity detected

ACTIVE Mode

In this mode, the CPU is executing application code and all digital and analog peripherals are available on demand. Dynamic clocking disables local clocks in peripherals not in use. This mode corresponds to the Arm Cortex-M4 processor with FPU Active mode.

SLEEP Mode

This mode allows for lower power consumption operation than ACTIVE mode. The CPU is asleep, peripherals are on, and the standard DMA block is available. The GPIO or any active peripheral can be configured to interrupt and cause transition to the ACTIVE mode. This mode corresponds to the Arm Cortex-M4 processor with FPU Sleep mode.

DEEPSLEEP Mode

In this mode, CPU and critical peripheral configuration settings and all volatile memory are preserved.

The device status is a follows:

- The CPU is powered down. The system state and all SRAM is retained.
- The GPIO pins retain their state.
- The transition from DEEPSLEEP to ACTIVE mode is faster than the transition from BACKUP mode because system

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initialization is not required.

- The system oscillators are all disabled to provide additional power savings over SLEEP mode.
- LPUART0 and LPTMR0/1 can be active and are optional wake-up sources.

This mode corresponds to the Arm Cortex-M4 with FPU DeepSleep mode.

BACKUP Mode

This mode places the CPU in a static, low-power state. BACKUP mode supports the same wake-up sources as DEEPSLEEP mode.

The device status is as follows:

- The CPU is powered down.
- SRAM retention as per <u>Table 1</u>. Each of the RAM blocks can be retained.
- LPUART0 and LPTMR0/1 can be active and are optional wake-up sources.

Table 1. BACKUP Mode RAM Retention

RAM BLOCK	RAM SIZE WITHOUT ECC (KB)	RAM SIZE WITH ECC (KB)
SYSRAM0	20	16
SYSRAM1	20	16
SYSRAM2	40	32
SYSRAM3	80	64

STORAGE Mode

The device status is as follows:

- The CPU is powered off.
- All peripherals are powered off.
- Wake-up from GPIO interrupt.
- RTC can be enabled.
- No SRAM retention.

Real-Time Clock

A real-time clock (RTC) keeps the time of day in absolute seconds. The 32-bit seconds register can count up to approximately 136 years and be translated to calendar format by application software.

The RTC provides a time-of-day alarm that can be programmed to any future value between 1 second and 12 days. When configured for long intervals, the time-of-day alarm can be used as a power-saving timer, allowing the device to remain in an extremely low-power mode, but still awaken periodically to perform assigned tasks. A second independent 32-bit 1/4096 subsecond alarm can be programmed between 244µs and 12 days. Both can be configured as recurring alarms. When enabled, either alarm can cause an interrupt or wake the device from most low-power modes.

The time base is generated by a 32.768kHz crystal or an external clock source that must meet the electrical/timing requirements in the *Electrical Characteristics* table.

An RTC calibration feature provides the ability for user-software to compensate for minor variations in the RTC oscillator, crystal, temperature, and board layout. Enabling the 32KCAL alternate function outputs a timing signal derived from the RTC. External hardware can measure the frequency and adjust the RTC frequency in increments of ±127ppm with 1ppm resolution. Under most circumstances, the oscillator does not require any calibration.

Windowed Watchdog Timer (WWDT)

Microcontrollers are often used in harsh environments where electrical noise and electromagnetic interference (EMI) are abundant. Without proper safeguards, these hazards can disturb device operation and corrupt program execution. One of the most effective countermeasures is the windowed watchdog timer (WWDT), which detects runaway code or system unresponsiveness.

The WWDT is a 32-bit, free-running counter with a configurable prescaler. When enabled, the WWDT must be periodically reset by the application software. Failure to reset the WWDT within the user-configurable timeout period

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indicates that the application software is not operating correctly and results in a WWDT timeout. A WWDT timeout can trigger an interrupt, system reset, or both. Either response forces the instruction pointer to a known good location before resuming instruction execution. The windowed timeout period feature provides more detailed monitoring of system operation, requiring the WWDT to be reset within a specific window of time.

The WWDT supports multiple clock options:

- 100MHz IPO
- 16MHz to 32MHz ERFO (external crystal required)
- 7.3728MHz IBRO
- 80kHz INRO
- 32.768kHz ERTCO (external crystal required)
- External square-wave clock up to 50MHz
- PCLK

The MAX32670/MAX32671 provide two instances of the windowed watchdog timer (WWDT0 and WWDT1).

32-Bit Timer/Counter/PWM (TMR, LPTMR)

General-purpose, 32-bit timers provide timing, capture/compare, or generation of pulse-width modulated (PWM) signals with minimal software interaction.

The timer provides the following features:

- 32-bit up/down autoreload
- Programmable prescaler
- PWM output generation
- Capture, compare, and capture/compare capability
- External pin multiplexed with GPIO for timer input, clock gating or capture
- Timer output pin
- TMR0–TMR3 can be configured as 2 × 16-bit general-purpose timers
- Timer interrupt

The MAX32670/MAX32671 provide six 32-bit timers (TMR0, TMR1, TMR2, TMR3, LPTMR0, and LPTMR1). LPTMR0 and LPTMR1 are capable of operation in the low-power SLEEP, DEEPSLEEP, and BACKUP modes.

I/O functionality is supported for all of the timers. Note that the function of a port can be multiplexed with other functions on the GPIO pins, so it might not be possible to use all the ports depending on the device configuration. See <u>Table 2</u> for individual timer features.

Table 2. Timer Configuration Options

			•								
	SINGLE	DUAL	POWER				CLOC	K SOU	RCE		
INSTANCE	32 BIT	16 BIT	MODE	AOD_PCLK	PCLK	IBRO	ERFO	INRO	ERTCO	EXT_CLK1	EXT_CLK2
TMR0	YES	YES	ACTIVE SLEEP	NO	YES	YES	YES	NO	NO	YES	NO
TMR1	YES	YES	ACTIVE SLEEP	NO	YES	YES	YES	NO	NO	YES	NO
TMR2	YES	YES	ACTIVE SLEEP	NO	YES	YES	YES	NO	NO	YES	NO
TMR3	YES	YES	ACTIVE SLEEP	NO	YES	YES	YES	NO	NO	YES	NO
LPTMR0	YES	NO	ACTIVE SLEEP	YES	NO	NO	NO	YES	YES	NO	YES
LETIVIRO	123	INO	DEEPSLEEP BACKUP	NO	INO	INO	NO	123	YES	INO	123
LPTMR1	YES	NO	ACTIVE SLEEP	YES	NO	NO	NO	YES	YES	NO	YES

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Table 2. Timer Configuration Options (continued)

BACKUP 1100		DEEPSLEEP NO NO					
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Serial Peripherals

I²C Interface (I2C)

The I²C interface is a bidirectional, two-wire serial bus that provides a medium-speed communications network. It can operate as a one-to-one, one-to-many, or many-to-many communications medium. These engines support Standard-mode, Fast-mode Plus and high-speed mode I²C speeds. It provides the following features:

- Master or slave mode operation
 - · Supports up to four different slave addresses in slave mode
- Supports standard 7-bit addressing or 10-bit addressing
- RESTART condition
- Interactive receive mode
- Tx FIFO preloading
- Support for clock stretching to allow slower slave devices to operate on higher speed busses
- Multiple transfer rates
 - · Standard-mode: 100kbps
 - Fast-mode: 400kbps
 - · Fast-mode Plus: 1000kbps
 - High-speed mode: 3400kbps
- Internal filter to reject noise spikes
- · Receiver FIFO depth of 8 bytes
- Transmitter FIFO depth of 8 bytes

The MAX32670/MAX32671 provide three instances of the I²C peripheral (I2C0, I2C1, and I2C2).

Serial Peripheral Interface (SPI)

The serial peripheral interface (SPI) is a highly configurable, flexible, and efficient synchronous interface among multiple SPI devices on a single bus. The bus uses a single clock signal and multiple data signals, and one or more slave select lines to address only the intended target device. The SPI operates independently and requires minimal processor overhead.

The provided SPI peripherals can operate in either slave or master mode and provide the following features:

- SPI modes 0, 1, 2, and 3 for single-bit communication
- 3- or 4-wire mode for single-bit slave device communication
- Full-duplex operation in single-bit, 4-wire mode
- Multimaster mode fault detection
- · Programmable interface timing
- Programmable SCK frequency and duty cycle
- 32-byte transmit and receive FIFOs
- Slave select assertion and deassertion timing with respect to leading/trailing SCK edge

The MAX32670/MAX32671 provide three instances of the SPI peripheral (SPI0, SPI1, and SPI2). See <u>Table 3</u> for configuration options.

Table 3. SPI Configuration Options

INSTANCE	DATA	SLAVE SELECT LINES	MAXIMUM FREQUENCY MASTER MODE (MHz)	MAXIMUM FREQUENCY SLAVE MODE (MHz)
		40 TQFN		

Table 3. SPI Configuration Options (continued)

SPI0	3 wire, 4 wire	1	50	50
SPI1	3 wire, 4 wire	1	50	50
SPI2	3 wire, 4 wire	1	50	50

I²S Interface (I2S)

The I²S interface is a bidirectional, four-wire serial bus that provides serial communications for codecs and audio amplifiers compliant with the I²S Bus Specification, June 5, 1996. It provides the following features:

- · Master and slave mode operation
- Support for 4 channels
- 8-, 16-, 24-, and 32-bit frames
- Receive and transmit DMA support
- Wakeup on FIFO status (full/empty/threshold)
- Pulse density modulation support for receive channel
- Word select polarity control
- First bit position selection
- Interrupts generated for FIFO status
- Receiver FIFO depth of 32 bytes
- Transmitter FIFO depth of 32 bytes

The MAX32670/MAX32671 provide one instance of the I²S peripheral (I2S0).

UART (UART, LPUART)

The universal asynchronous receiver-transmitter (UART, LPUART) interface supports full-duplex asynchronous communication with optional hardware flow control (HFC) modes to prevent data overruns. If HFC mode is enabled on a given port, the system uses two extra pins to implement the industry-standard request to send (RTS) and clear to send (CTS) flow control signaling. Each instance is individually programmable.

- 2-wire interface or 4-wire interface with flow control
- 8-byte send/receive FIFO
- Full-duplex operation for asynchronous data transfers
- Interrupts available for frame error, parity error, CTS, Rx FIFO overrun, and FIFO full/partially full conditions
- Automatic parity and frame error detection
- Independent baud-rate generator
- Programmable 9th-bit parity support
- Multidrop support
- Start/stop bit support
- Hardware flow control using RTS/CTS
- Two DMA channels can be connected (read and write FIFOs)
- Programmable word size (5 bits to 8 bits)

The MAX32670/MAX32671 provide four instances of the UART peripheral (UART0, UART1, UART2, and LPUART0). LPUART0 is capable of operation in the low-power SLEEP, DEEPSLEEP, and BACKUP modes. See <u>Table 4</u> for configuration options.

Table 4. UART Configuration Options

INSTANCE	POWER MODE	CLOCK SOURCE								
	POWER WIODE	AOD_PCLK	PCLK	IBRO	ERFO	INRO	ERTCO	EXT_CLK1	EXT_CLK2	
UART0	ACTIVE	NO	YES	YES	YES	NO	NO	YES	NO	

Table 4. UART Configuration Options (continued)

UART1	ACTIVE	NO	YES	YES	YES	NO	NO	YES	NO
UART2	ACTIVE	NO	YES	YES	YES	NO	NO	YES	NO
LPUART0	ACTIVE/SLEEP	YES	NO	NO	NO	YES	YES	NO	YES
	DEEPSLEEP/BACKUP	NO	INO	NO	INO	150	150	INO	TES

Security

AES

The dedicated hardware-based AES engine supports the following algorithms:

- AES-128
- AES-192
- AES-256

The AES keys are automatically generated by the engine and stored in dedicated flash to protect against tampering. Key generation and storage is transparent to the user.

True Random Number Generator (TRNG)

Random numbers are a vital part of a secure application, providing random numbers that can be used for cryptographic seeds or strong encryption keys to ensure data privacy.

Software can use random numbers to trigger asynchronous events that result in nondeterministic behavior. This is helpful in thwarting replay attacks or key search approaches. An effective true random number generator (TRNG) must be continuously updated by a high-entropy source.

The provided TRNG is continuously driven by a physically-unpredictable entropy source. It generates a 128-bit true random number in 128 system clock cycles.

The TRNG can support the system-level validation of many security standards such as FIPS 140-2, PCI-PED, and Common Criteria. Contact Analog Devices for details of compliance with specific standards.

CRC Module

A cyclic redundancy check (CRC) hardware module provides fast calculations and data integrity checks by application software. The CRC module supports the following polynomials:

- CRC-16-CCITT
- CRC-32 (X³² + X²⁶ + X²³ + X²² + X¹⁶ + X¹² + X¹¹ + X¹⁰ + X⁸ + X⁷ + X⁵ + X⁴ + X² + X + 1)

Bootloader

The bootloader allows loading and verification of program memory through a serial interface. Features include:

- Bootloader interface through UART
- Program loading of Motorola[®] SREC format files
- Permanent lock state prevents altering or erasing program memory
- Access to the USN for device or customer application identification
- Disable SWD interface to block debug access port functionality

Secure Boot

The optional secure boot feature ensures software integrity by automatically comparing program memory against a stored HMAC SHA-256 hash value after every reset. Programs that fail the integrity check indicate corrupted or modified program memory and are prevented from executing any instructions.

Devices with the secure boot feature also provide an optional challenge/response that authenticates before executing bootloader commands.

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Debug and Development Interface (SWD)

The serial wire debug interface is used for code loading and in-circuit emulation (ICE) debug activities. All devices in mass production have the debugging/development interface enabled.

Applications Information

Bypass Capacitors

The proper use of bypass capacitors reduces noise generated by the IC into the ground plane. The <u>Pin Descriptions</u> table indicates which pins should be connected to bypass capacitors, and the appropriate ground plane.

It is recommended that one instance of a bypass capacitor should be connected to each pin/ball of the IC package. For example, if the <u>Pin Descriptions</u> table shows four device pins associated with voltage supply A, a separate capacitor should be connected to each pin for a total of four capacitors.

Capacitors should be placed as close as possible to their corresponding device pins. Pins which recommend more than one value of capacitor per pin should place them in parallel with the lowest value capacitor first, closest to the pin.

Bootloader Activation

The bootloader starts if the <u>Table 5</u> pins are in their active state before exiting any reset and remain active until the bootloader sends the first command prompt. If the pins are not in their active state, the device will perform a secure boot and, if successful, will begin execution of the application code. The design must ensure that the activation pins and the RSTN pin are available to the host so it can activate the bootloader.

Table 5. Bootloader Activation Summary

ACTIVATION PINS						
UART0_RX (Active Low)	SWDCLK (Active Low)					

Typical Fixed Current Consumption Temperature Variance

Single-Supply ACTIVE Mode

Table 6. Single-Supply Operation Fixed V_{DD} Current Consumption ACTIVE Mode

PARAMETER	SYMBOL	COMMON CONDITIONS	CONDITIONS		T	YPICA	L		UNITS
PARAMETER	STIVIBUL	COMMON CONDITIONS	CONDITIONS	-40°C	25°C	55°C	85°C	105°C	UNITS
V _{DD} Current ACTIVE Mode	IDD_FACTS	Fixed, IPO enabled, total current into V_{DD} pin, V_{DD} = 3.3V, CPU in ACTIVE mode 0MHz execution, ECC disabled, inputs tied to V_{SS} or V_{DD} , outputs source/sink 0mA Fixed, IPO enabled, total current into V_{DD} pin, V_{DD} = 1.8V, CPU in ACTIVE mode 0MHz execution, ECC disabled, inputs tied to V_{SS} or V_{DD} , outputs source/sink 0mA	OVR = [10], internal regulator set to 1.1V	634	735	863	1127	1477	μΑ
			OVR = [01], internal regulator set to 1.0V	544	659	760	956	1241	μA
			OVR = [00], internal regulator set to 0.9V	474	563	654	819	1063	μA
			OVR = [10], internal regulator set to 1.1V	618	754	847	1099	1435	μA
			OVR = [01], internal regulator set to 1.0V	525	633	734	961	1242	μΑ

Table 6. Single-Supply Operation Fixed V_{DD} Current Consumption ACTIVE Mode (continued)

		OVR = [00], internal regulator set to 0.9V	455	538	626	815	1052	μA
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Single-Supply SLEEP Mode

Table 7. Single-Supply Operation Fixed V_{DD} Current Consumption SLEEP Mode

PARAMETER	SYMBOL	COMMON CONDITIONS	CONDITIONS		Т	YPICA	L		UNITS
PARAMETER	STWIDOL	CONDITIONS	-40°C	25°C	55°C	85°C	105°C	UNITS	
V _{DD} Current SLEEP Mode			OVR = [10], internal regulator set to 1.1V	634	735	863	1127	1477	μΑ
		Fixed, IPO enabled, total current into V_{DD} pin, V_{DD} = 3.3V, CPU in SLEEP mode, ECC disabled, inputs tied to V_{SS} or V_{DD} , outputs source/sink 0mA	OVR = [01], internal regulator set to 1.0V	544	659	760	956	1241	μΑ
	IDD_FSLPS		OVR = [00], internal regulator set to 0.9V	474	563	654	819	1063	μΑ
		Fixed, IPO enabled, total current into V _{DD} pin, V _{DD} = 1.8V, CPU in SLEEP mode, ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [10], internal regulator set to 1.1V	618	754	847	1099	1435	μΑ
			OVR = [01], internal regulator set to 1.0V	525	633	734	961	1242	μΑ
			OVR = [00], internal regulator set to 0.9V	455	538	626	815	1052	μΑ

Single-Supply DEEPSLEEP Mode

Table 8. Single-Supply Operation Fixed V_{DD} Current Consumption DEEPSLEEP Mode

PARAMETER	SYMBOL	COMMON CONDITIONS	CONDITIONS		UNITS				
PARAMETER	STWIBOL	COMMON CONDITIONS	CONDITIONS	-40°C	25°C	55°C	85°C	105°C	UNITS
V _{DD} Fixed Current		Standby state with full data	V _{DD} = 3.3V	1.44	4	9.7	24.7	49	μA
DEEPSLEEP Mode	DD_FDSLPS	retention and 160KB SRAM retained	V _{DD} = 1.8V	1.3	3.7	9.3	24.2	48.3	μA

Single-Supply BACKUP Mode

Table 9. Single-Supply Operation Fixed V_{DD} Current Consumption BACKUP Mode

_									
PARAMETER	SYMBOL	COMMON	CONDITIONS		1	YPICA	L		UNITS
PARAMETER	STWIBOL	CONDITIONS	CONDITIONS	-40°C	25°C	55°C	85°C	105°C	UNITS

Table 9. Single-Supply Operation Fixed V_{DD} Current Consumption BACKUP Mode (continued)

		V _{DD} = 3.3V, RTC disabled	0KB SRAM retained, retention regulator disabled	0.28	0.38	0.57	1	1.75	μΑ
			20KB SRAM retained	0.64	1.08	1.96	4.3	8.2	μA
			40KB SRAM retained	0.72	1.4	2.84	6.6	12.8	μA
			80KB SRAM retained	0.89	1.9	4.1	9.9	19.5	μA
V _{DD} Fixed Current	1		160KB SRAM retained	1.2	2.8	6.1	15.2	30.3	μA
BACKUP Mode	IDD_FBKUS		0KB SRAM retained, retention regulator disabled	0.13	0.15	0.22	0.48	1	μΑ
		V _{DD} = 1.8V,	20KB SRAM retained	0.49	0.86	1.64	3.8	7.5	μA
		RTC disabled	40KB SRAM retained	0.58	1.2	2.5	6.1	12.1	μA
			80KB SRAM retained	0.75	1.7	3.7	9.4	18.7	μA
			160KB SRAM retained	1.06	2.58	5.8	14.7	29.7	μA

Single-Supply STORAGE Mode

Table 10. Single-Supply Operation Fixed V_{DD} Current Consumption STORAGE Mode

PARAMETER	SYMBOL CONDITIONS			TYPICAL					
PARAMETER	STWBOL	CONDITIONS	-40°C	25°C	55°C	85°C	105°C	UNITS	
V _{DD} Fixed Current STORAGE Mode	l	V _{DD} = 3.3V	0.23	0.33	0.51	0.96	1.68	μA	
VDD Fixed Current STORAGE Mode	IDD_FSTOS	V _{DD} = 1.8V	0.094	0.11	0.19	0.45	0.94	μA	

Dual-Supply ACTIVE Mode

Table 11. Dual-Supply Operation Fixed V_{CORE} Current Consumption ACTIVE Mode

PARAMETER	SYMBOL	COMMON CONDITIONS	CONDITIONS			UNITS			
PARAMETER	STWIBOL	COMMON CONDITIONS	CONDITIONS	-40°C	25°C	55°C	85°C	105°C	ONTO
		Fixed, IPO enabled, total current	OVR = [10], V _{CORE} = 1.1V	222	311	410	663	996	μΑ
VCORE Current ACTIVE Mode	ICORE_FACTD	into V _{CORE} pin, CPU in ACTIVE mode 0MHz execution, ECC disabled, inputs tied to V _{SS} or	OVR = [01], V _{CORE} = 1.0V	131	209	310	483	760	μΑ
	V _{DD} , outputs source/sink 0mA	OVR = [00], V _{CORE} = 0.9V	54	106	171	317	52	μΑ	

Dual-Supply ACTIVE Mode

Table 12. Dual-Supply Operation Fixed V_{DD} Current Consumption ACTIVE Mode

PARAMETER	SYMBOL	COMMON CONDITIONS	CONDITIONS			UNITS			
PARAMETER		COMMON CONDITIONS	CONDITIONS	-40°C	25°C	55°C	85°C	105°C	UNITS
V _{DD} Current ACTIVE Mode	I _{DD_FACTD}	Fixed, IPO enabled, total current into V _{DD} pin, V _{DD} = 3.3V, CPU in SLEEP mode, ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [10], internal regulator set to 1.1V	360	391	406	424	441	μA

Table 12. Dual-Supply Operation Fixed V_{DD} Current Consumption ACTIVE Mode (continued)

<u>'</u>								
		OVR = [01], internal regulator set to 1.0V	360	390	406	424	441	μΑ
		OVR = [00], internal regulator set to 0.9V	356	387	402	420	437	μΑ
		OVR = [10], internal regulator set to 1.1V	341	372	388	406	422	μΑ
	Fixed, IPO enabled, total current into V _{DD} pin, V _{DD} = 1.8V, CPU in SLEEP mode, ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink 0mA	OVR = [01], internal regulator set to 1.0V	341	372	387	405	421	μΑ
		OVR = [00], internal regulator set to 0.9V	338	369	384	401	417	μΑ

Dual-Supply SLEEP Mode

Table 13. Dual-Supply Operation Fixed V_{CORE} Current Consumption SLEEP Mode

PARAMETER	SYMBOL	COMMON CONDITIONS	CONDITIONS			UNITS			
PARAMETER	STIMBOL	COMMON CONDITIONS	CONDITIONS	-40°C	25°C	55°C	85°C	105°C	UNITS
		Fixed, IPO enabled, total current	OVR = [10], V _{CORE} = 1.1V	222	311	410	663	996	μΑ
V _{CORE} Current SLEEP Mode	ICORE_FSLPD	into V _{CORE} pin, CPU in SLEEP mode, ECC disabled, inputs tied to	OVR = [01], V _{CORE} = 1.0V	131	209	310	483	105°C	μΑ
		0mA	OVR = [00], V _{CORE} = 0.9V	54	106	171	317	523	μΑ

Dual-Supply SLEEP Mode

Table 14. Dual-Supply Operation Fixed $V_{\mbox{\scriptsize DD}}$ Current Consumption SLEEP Mode

PARAMETER	SYMBOL	COMMON CONDITIONS	CONDITIONS			UNITS			
PARAMETER	STIVIBUL	COMMON CONDITIONS	CONDITIONS	-40°C	25°C	55°C	85°C	105°C	UNITS
		Fixed, IPO enabled, total current into	OVR = [10], V _{CORE} = 1.1V	360	391	406	424	441	μΑ
V _{DD} Current SLEEP Mode	I _{DD_FSLPD}	V _{DD} pin, V _{DD} = 3.3V, CPU in SLEEP mode, ECC disabled, inputs tied to V _{SS} or V _{DD} , outputs source/sink	OVR = [01], V _{CORE} = 1.0V	360	390	406	424		μΑ
		0mA	OVR = [00], V _{CORE} = 0.9V	356	387	402	420		μΑ

Table 14. Dual-Supply Operation Fixed V_{DD} Current Consumption SLEEP Mode (continued)

	Fixed, IPO enabled, total current into	OVR = [10], V _{CORE} = 1.1V	341	372	388	406	422	μА
	V_{DD} pin, V_{DD} = 1.8V, CPU in SLEEP mode, ECC disabled, inputs tied to V_{C}	OVR = [01], V _{CORE} = 1.0V	341	372	387	405	421	μΑ
	0mA	OVR = [00], V _{CORE} = 0.9V	338	369	384	401	417	μA

Dual-Supply DEEPSLEEP Mode

Table 15. Dual-Supply Operation Fixed V_{CORE} Current Consumption DEEPSLEEP Mode

PARAMETER	SYMBOL	CONDITIONS			ГҮРІСА	L		UNITS
PARAMETER	STWIBOL	CONDITIONS	-40°C	25°C	55°C	85°C	105°C	UNITS
		V _{DD} = 3.3V, V _{CORE} = 1.1V	4.9	10.5	20	43	78	μА
V Fixed Current DEEDSLEED Made	CORE_FDSLPD	V _{DD} = 3.3V, V _{CORE} = 0.855V	1.26	4	9.8	25	49	μΑ
V _{CORE} Fixed Current, DEEPSLEEP Mode		V _{DD} = 1.8V, V _{CORE} = 1.1V	4.9	10.5	20	43.6	78.9	μA
		V _{DD} = 1.8V, V _{CORE} = 0.855V	1.25	4	9.8	25	49	μА

Dual-Supply DEEPSLEEP Mode

Table 16. Dual-Supply Operation Fixed V_{DD} Current Consumption DEEPSLEEP Mode

PARAMETER	SYMBOL	CONDITIONS			TYPICA	L		UNITS
PARAMETER	STWIBOL	CONDITIONS	-40°C	25°C	55°C	85°C	105°C	UNITS
		V _{DD} = 3.3V, V _{CORE} = 1.1V	0.262	0.36	0.531	0.965	1.67	μΑ
V Fixed Current DEEDSLEED Made		$V_{DD} = 3.3V,$ $V_{CORE} = 0.855V$	0.254	0.36	0.532	0.964	1.69	μΑ
V _{DD} Fixed Current, DEEPSLEEP Mode	IDD_FDSLPD	V _{DD} = 1.8V, V _{CORE} = 1.1V	0.127	0.149	0.22	0.48	0.99	μΑ
		V _{DD} = 1.8V, V _{CORE} = 0.855V	0.127	0.149	0.22	0.48	0.99	μА

Dual-Supply BACKUP Mode

Table 17. Dual-Supply Operation Fixed V_{CORE} Current Consumption BACKUP Mode

PARAMETER	SYMBOL COMMON CONDITIONS		CONDITIONS			UNITS			
PARAMETER	STIMBOL	COMMON CONDITIONS	CONDITIONS	-40°C	25°C	55°C	85°C	105°C	UNITS
V _{CORE} Fixed Current, BACKUP Mode	I _{CORE_FBKUD}	0KB SRAM retained with RTC disabled, retention regulator disabled	V _{DD} = 3.3V, V _{CORE} = 1.1V	0.115	0.3	0.856	2.6	5.7	μΑ

Table 17. Dual-Supply Operation Fixed V_{CORE} Current Consumption BACKUP Mode (continued)

(continued)		,						
		V _{DD} = 3.3V, V _{CORE} = 0.855V	0.058	0.19	0.626	2.06	4.67	μΑ
		V _{DD} = 1.8V, V _{CORE} = 1.1V	0.11	0.297	0.86	2.6	5.7	μΑ
		V _{DD} = 1.8V, V _{CORE} = 0.855V	0.058	0.187	0.623	2.05	4.69	μΑ
		V _{DD} = 3.3V, V _{CORE} = 1.1V	0.595	1.37	2.93	7.1	13.8	μΑ
	20KB SRAM retained with RTC disabled	V _{DD} = 3.3V, V _{CORE} = 0.855V	0.177	0.6	1.64	4.6	9.7	μΑ
		V _{DD} = 1.8V, V _{CORE} = 1.1V	0.59	1.37	2.93	7.1	13.9	μΑ
		V _{DD} = 1.8V, V _{CORE} = 0.855V	0.179	0.6	1.65	4.6	9.7	μΑ
		V _{DD} = 3.3V, V _{CORE} = 1.1V	1.07	2.39	4.86	11.2	21.1	μΑ
	40KB SRAM retained with	V _{DD} = 3.3V, V _{CORE} = 0.855V	0.3	0.99	2.55	6.95	14.2	μΑ
	RTC disabled	V _{DD} = 1.8V, V _{CORE} = 1.1V	1.07	2.39	4.9	11.2	21.3	μΑ
		V _{DD} = 1.8V, V _{CORE} = 0.855V	0.3	0.99	2.56	7	14.3	μΑ
		V _{DD} = 3.3V, V _{CORE} = 1.1V	1.97	4.15	7.9	17.1	31.5	μΑ
	80KB SRAM retained with RTC disabled 160KB SRAM retained with RTC disabled	V _{DD} = 3.3V, V _{CORE} = 0.855V	0.52	1.6	3.9	10.2	20.5	μΑ
		V _{DD} = 1.8V, V _{CORE} = 1.1V	1.99	4.15	7.9	17.2	31.7	μΑ
		V _{DD} = 1.8V, V _{CORE} = 0.855V	0.52	1.6	3.9	10.2	20.6	μΑ
		V _{DD} = 3.3V, V _{CORE} = 1.1V	3.7	7.4	13.2	27.2	49	μΑ
		V _{DD} = 3.3V, V _{CORE} = 0.855V	0.94	2.7	6.2	15.7	31.2	μΑ

Table 17. Dual-Supply Operation Fixed $V_{\mbox{CORE}}$ Current Consumption BACKUP Mode (continued)

Dual-Supply BACKUP Mode

Table 18. Dual-Supply Operation Fixed V_{DD} Current Consumption BACKUP Mode

DADAMETED	OVMDOL	COMMON CONDITIONS	CONDITIONS		1	TYPICA	L		LINUTO	
PARAMETER	SYMBOL	COMMON CONDITIONS	CONDITIONS	-40°C	25°C	55°C	85°C	105°C	UNIIS	
disabled, retention regulator disabled			V _{DD} = 3.3V, V _{CORE} = 1.1V	0.26	0.36	0.53	0.97	1.7	μA	
		0KB SRAM retained with RTC	0KB SRAM retained with RTC	V _{DD} = 3.3V, V _{CORE} = 0.855V	0.26	0.36	0.53	0.97	1.7	μΑ
		V _{DD} = 1.8V, V _{CORE} = 1.1V	0.13	0.15	0.22	0.48	0.99	μA		
		V _{DD} = 1.8V, V _{CORE} = 0.855V	0.13	0.15	0.22	0.48	0.99	μA		
			V _{DD} = 3.3V, V _{CORE} = 1.1V	0.26	0.36	0.53	0.97	1.7	μA	
		V ₀	V _{DD} = 3.3V, V _{CORE} = 0.855V	0.26	0.36	0.53	0.97	1.7	μA	
V _{DD} Fixed Current, BACKUP Mode	I _{DD_FBKUD}	disabled	V _{DD} = 1.8V, V _{CORE} = 1.1V	0.13	0.15	0.22	0.48	0.99	μA	
			V _{DD} = 1.8V, V _{CORE} = 0.855V	0.13	0.15	0.22	0.48	0.99	μA	
			V _{DD} = 3.3V, V _{CORE} = 1.1V	0.26	0.36	0.53	0.97	1.7	μA	
		40KB SRAM retained with RTC	V _{DD} = 3.3V, V _{CORE} = 0.855V	0.26	0.36	0.53	0.97	1.7	μΑ μΑ μΑ μΑ μΑ	
		disabled	V _{DD} = 1.8V, V _{CORE} = 1.1V	0.13	0.15	0.22	0.48	0.99	μA	
			V _{DD} = 1.8V, V _{CORE} = 0.855V	0.13	0.15	0.22	0.48	0.99	μΑ	
		80KB SRAM retained with RTC disabled	V _{DD} = 3.3V, V _{CORE} = 1.1V	0.26	0.36	0.53	0.97	1.7	μΑ	

Table 18. Dual-Supply Operation Fixed V_{DD} Current Consumption BACKUP Mode (continued)

(0011011101001)								
		V _{DD} = 3.3V, V _{CORE} = 0.855V	0.26	0.36	0.53	0.97	1.7	μΑ
		V _{DD} = 1.8V, V _{CORE} = 1.1V	0.13	0.15	0.22	0.48	0.99	μΑ
		V _{DD} = 1.8V, V _{CORE} = 0.855V	0.13	0.15	0.22	0.48	0.99	μΑ
		V _{DD} = 3.3V, V _{CORE} = 1.1V	0.26	0.36	0.53	0.97	1.7	μΑ
	160KB SRAM retained with RTC disabled	V _{DD} = 3.3V, V _{CORE} = 0.855V	0.26	0.36	0.53	0.97	1.7	μΑ
		V _{DD} = 1.8V, V _{CORE} = 1.1V	0.13	0.15	0.22	0.48	0.99	μΑ
		V _{DD} = 1.8V, V _{CORE} = 0.855V	0.13	0.15	0.22	0.48	0.99	μΑ

Dual-Supply STORAGE Mode

Table 19. Dual-Supply Operation Fixed $V_{\mbox{CORE}}$ Current Consumption STORAGE Mode

PARAMETER	SYMBOL	CONDITIONS	TYPICAL					UNITS
PARAMETER	STWIBOL	CONDITIONS	-40°C	25°C	55°C	UNITS		
V _{CORE} Fixed Current, STORAGE Mode		V _{DD} = 3.3V, V _{CORE} = 1.1V	0.064	0.25	0.8	2.58	5.71	μA
		V _{DD} = 3.3V, V _{CORE} = 1.1V	0.009	0.14	0.57	2.02	4.68	μA
	CORE_FSTOD	V _{DD} = 1.8V, V _{CORE} = 1.1V	0.064	0.25	0.8	2.57	5.72	μA
		V _{DD} = 1.8V, V _{CORE} = 1.1V	0.007	0.139	0.57	2.03	4.67	μA

Dual-Supply STORAGE Mode

Table 20. Dual-Supply Operation Fixed V_{DD} Current Consumption STORAGE Mode

PARAMETER	SYMBOL	CONDITIONS	TYPICAL					UNITS
	STIVIBUL	CONDITIONS	-40°C	25°C	55°C	85°C	93 1.66 92 1.64 44 0.95	
V _{DD} Fixed Current, STORAGE Mode		V _{DD} = 3.3V, V _{CORE} = 1.1V	0.22	0.32	0.49	0.93	1.66	μA
	1	V _{DD} = 3.3V, V _{CORE} = 1.1V	0.21	0.31	0.48	0.92	1.64	μA
	IDD_FSTOD	V _{DD} = 1.8V, V _{CORE} = 1.1V	0.092	0.11	0.19	0.44	0.95	μA
		V _{DD} = 1.8V, V _{CORE} = 1.1V	0.092	0.11	0.19	0.44	0.95	μA

High-Reliability, Ultra-Low-Power Microcontroller Powered by Arm Cortex-M4 Processor with FPU for Industrial and IoT

Ordering Information

PART	FLASH (KB)	SRAM (KB)	BOOTLOADER	SECURE BOOT	PIN-PACKAGE
MAX32670GTL+	384	160	YES	NO	40 TQFN
MAX32670GTL+T	384	160	YES	NO	40 TQFN
MAX32671GTL+*	384	160	YES	YES	40 TQFN
MAX32671GTL+T*	384	160	YES	YES	40 TQFN

T = Tape and reel. Full reel.

^{*}Future product—contact factory for availability.

High-Reliability, Ultra-Low-Power Microcontroller Powered by Arm Cortex-M4 Processor with FPU for Industrial and IoT

Revision History

REVISION NUMBER	REVISION DATE	DESCRIPTION	PAGES CHANGED
0	4/20	Initial release	_
1	5/20	Added MAX32671 and updated <i>Pin Descriptions</i> .	1–44
2	5/21	Updated <u>Pin Descriptions</u> . Updated <u>Simplified Block Diagram</u> . Added Bootloader and Secure Boot descriptions. Added new Bootloader Activation description in <u>Applications Information</u> . Added ERTCO stability capacitor requirements. Updated the <u>Clocking Scheme</u> . Changed the ERFO frequency range.	1, 2, 23, 32–35, 36, 39, 42–44
3	5/22	Updated <u>Benefits and Features</u> , the <u>POWER</u> section of the <u>Electrical Characteristics</u> table, and the <u>Pin Description</u> table. Removed <u>UART</u> speed indication. Updated the <u>Bootloader Activation</u> section in Applications Information. Added temperature variance Table 6 through Table 20 to the <u>Applications Information</u> section.	1, 8–14, 16–26, 36-38, 45, 48–55

